

# Smart Sensor Systems Design for Smartphones, Tablets and IoT: New Advanced Design Approach

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# Outline

- ① Introduction: Markets and Definitions
- ② Modern Challenges
- ③ Sensor Systems Design: Introduction
- ④ Advanced Sensor Systems Design
- ⑤ Sensors Systems Examples
- ⑥ The Future and Summary

# Outline

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# Internet of Things (IoT)

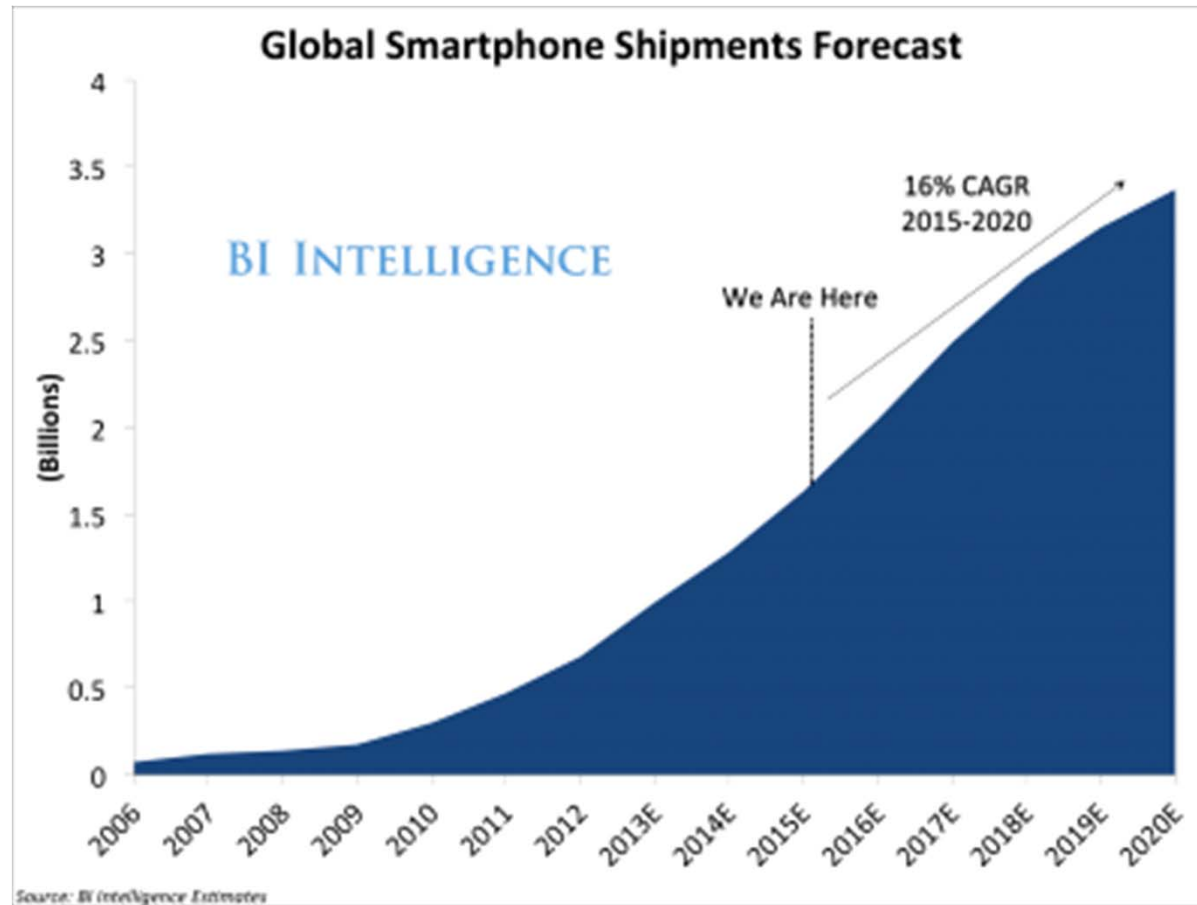


- Devices are focused on sensing and actuating of physical environment
- IoT represents the convergence in advances miniaturization, wireless connectivity, increased data storage capacity and batteries
- IoT wouldn't be possible without sensors
- A common requirement for IoT end nodes is the need for small size

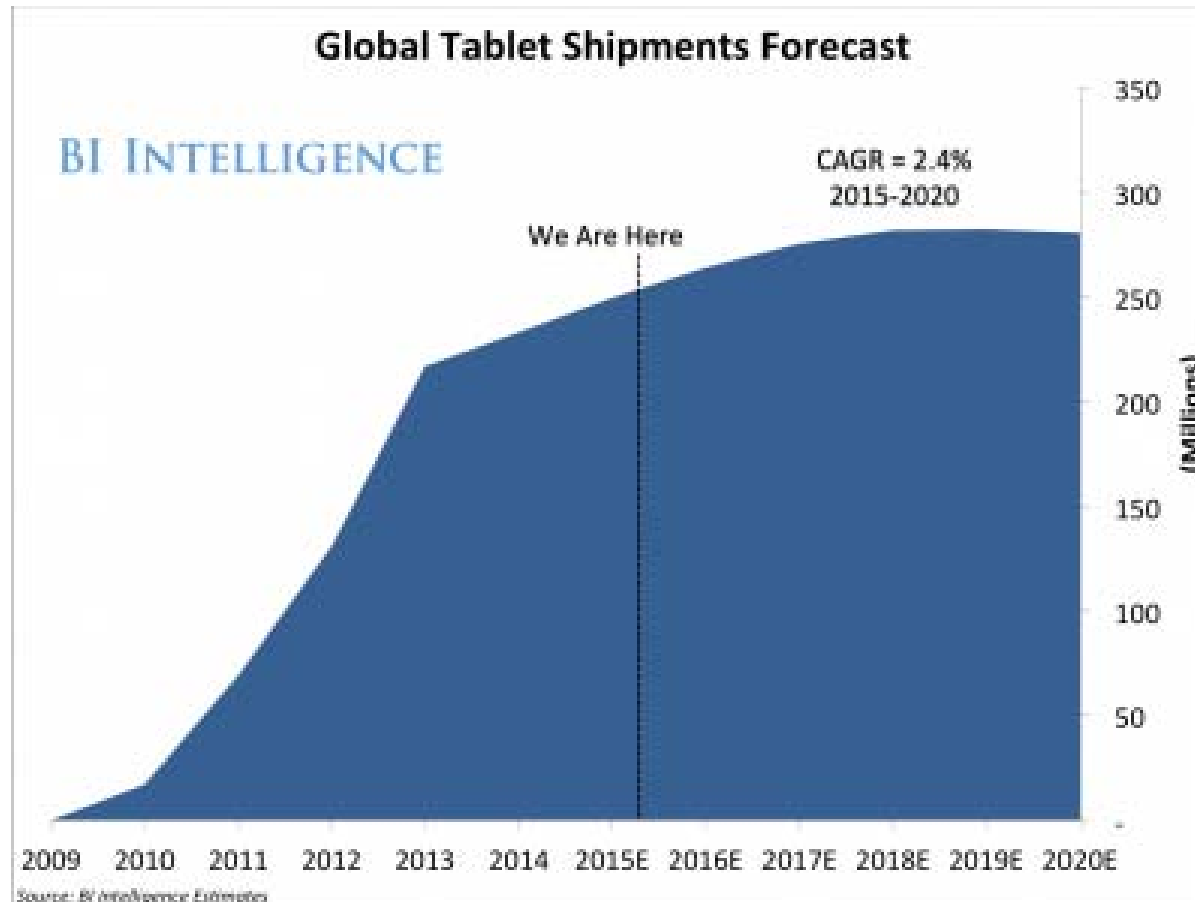
# Global Internet of Things (IoT) Market

- Grows at a compound annual growth rate CAGR of **31.72 %** over the period 2014-2019 (*Research and Markets*)
- **50 billion** devices are expected to be connected to the Internet by 2020 (*Cisco's IBSG*)
- By 2020, sensors will link **212 billion** of objects through the Internet of Things (IoT): (*IDC*)
- Internet of Things market is on track to hit **\$7.1 trillion** in 2020 (*IT research agency, IDC*)

# Global Smartphone Shipments



# Global Tablet Shipments



# Global Sensor Markets

- **Global Sensor Market** will reach US **\$154.4** Billion by 2020 with a five-year compound annual growth rate (CAGR) of 10.1% (*BCC Research*)
- **Global Microsensors Market** (including MEMS, biochips and nanosensors) will reach US **\$15.8** Billion by 2018 with CAGR) of 10.0 % (*BCC Research*)
- **Global Smart Sensors Market** to reach US **\$6.7** Billion by 2017 (*Global Industry Analysts, Inc.*)
- **European Smart Sensors Market** expected to grow up to US **\$2,402.15** million till 2018 with a CAGR of 39.90 %.

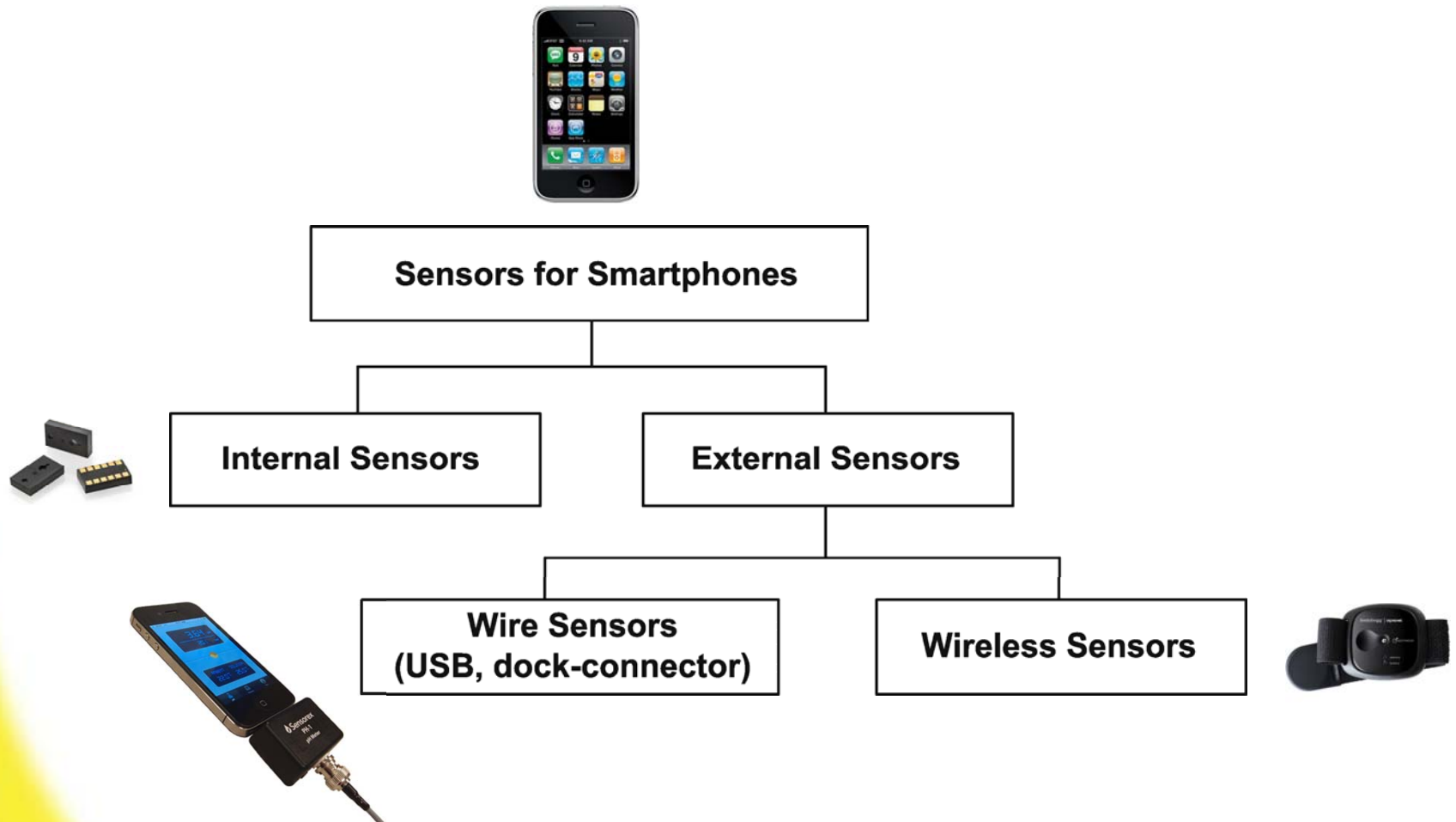


# Application Market Niche

- **Smartphone and Tablets Sensors Market** will rise to US **\$6.5 billion** in 2018 (*IHS*)
- **Combo-sensor Market** will growth to **1.5 Billion EUR** by 2016



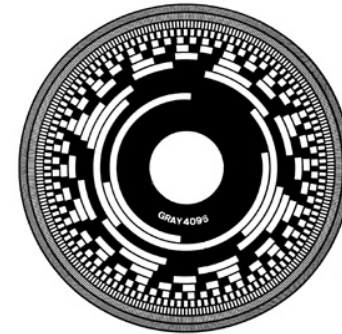
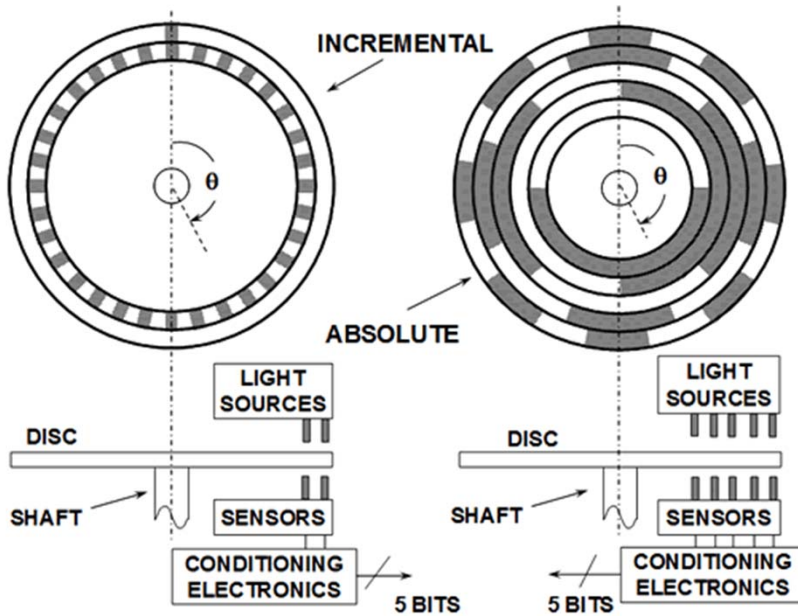
# Smartphone Sensors Classification



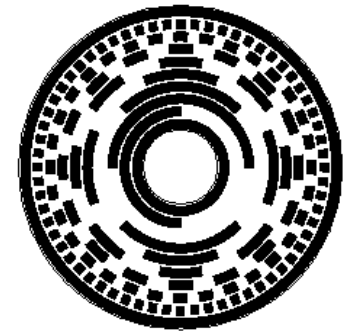
# Digital Sensors

- Number of physical phenomenon, on the basis of which direct conversion sensors with digital outputs can be designed, is essentially limited
- Angular-position encoders and cantilever-based accelerometers – examples of digital sensors of direct conversion
- There are not any nature phenomenon with discrete performances changing under pressure, temperature, etc.

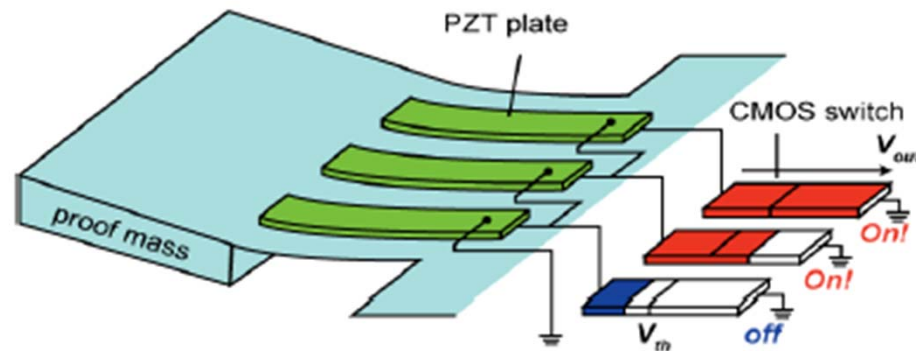
# Angular-Position Encoder



decimaal	Gray-code
0	0000
1	0001
2	0011
3	0010
4	0110
5	0111
6	0101
7	0100
8	1100
9	1101
10	1111
11	1110
enz.	enz.

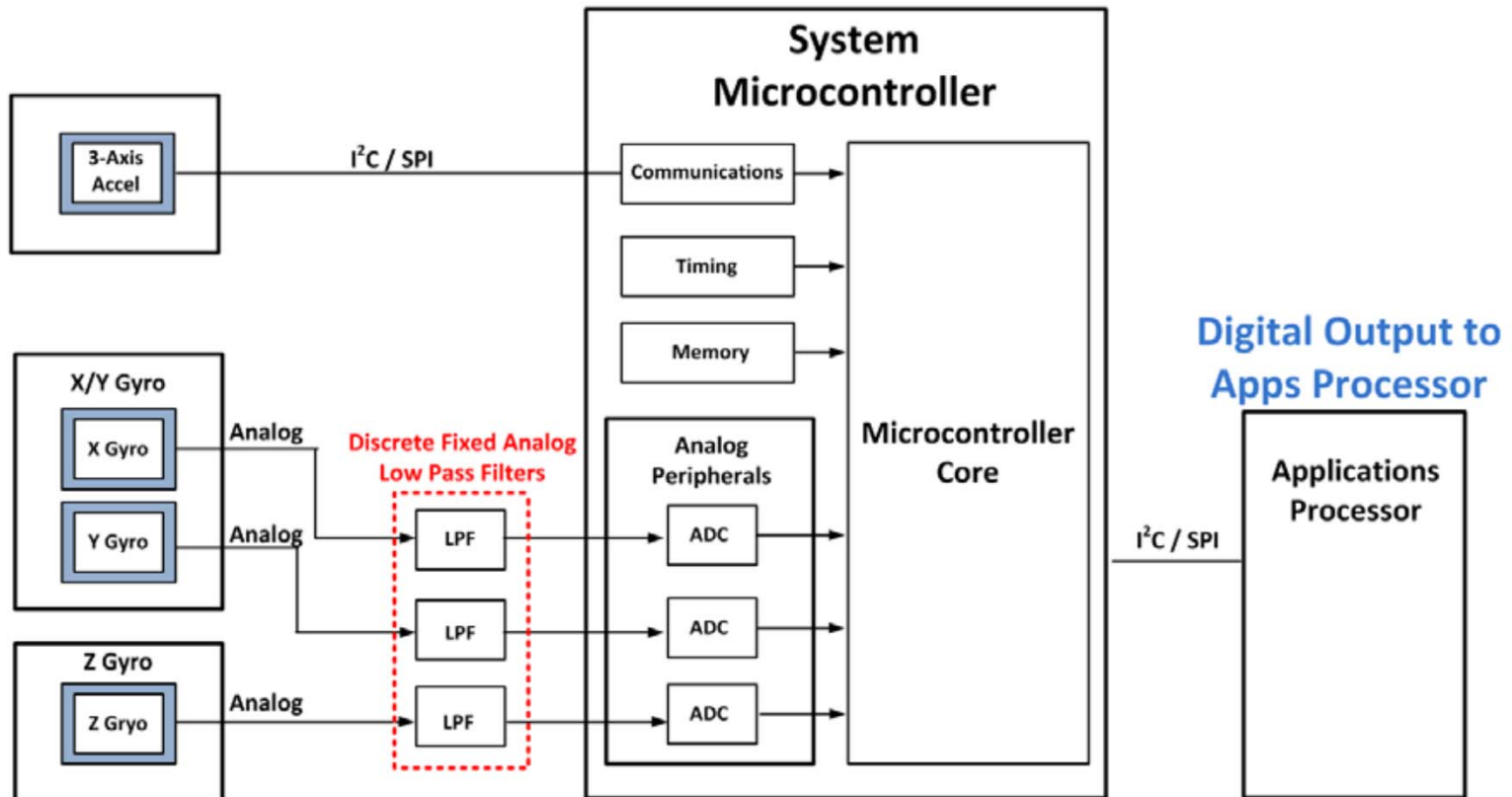


# Digital Accelerometer



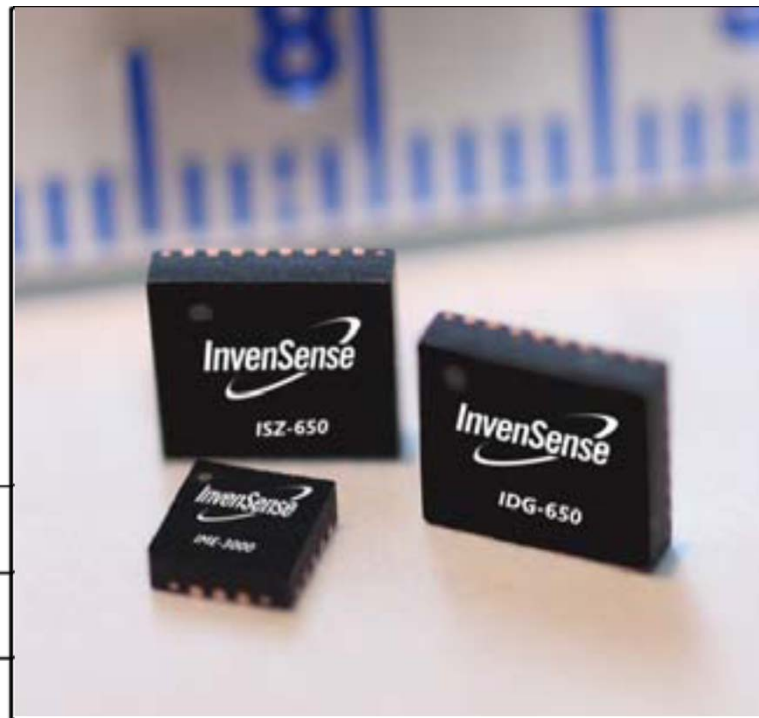
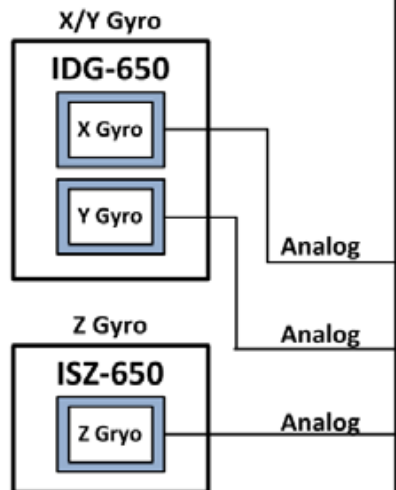
Toshihiro Itoh, Takeshi Kobayashi, Hironao Okada, A Digital Output Piezoelectric Accelerometer for Ultra-low Power Wireless Sensor Node, in *Proceedings of IEEE Sensors 2008*, 26-29 October 2008, Lecce, Italy, pp.542-545.

# 6-Axis Motion Processing Solution (I)

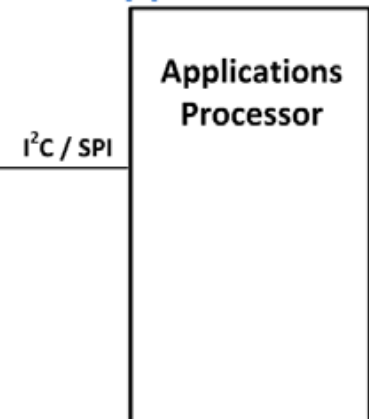


# 6-Axis Motion Processing Solution (II)

## Analog Gyros



## Digital Output to Apps Processor



# Modern Challenges

- ① Introduction: Markets and Definitions
- ② **Modern Challenges**
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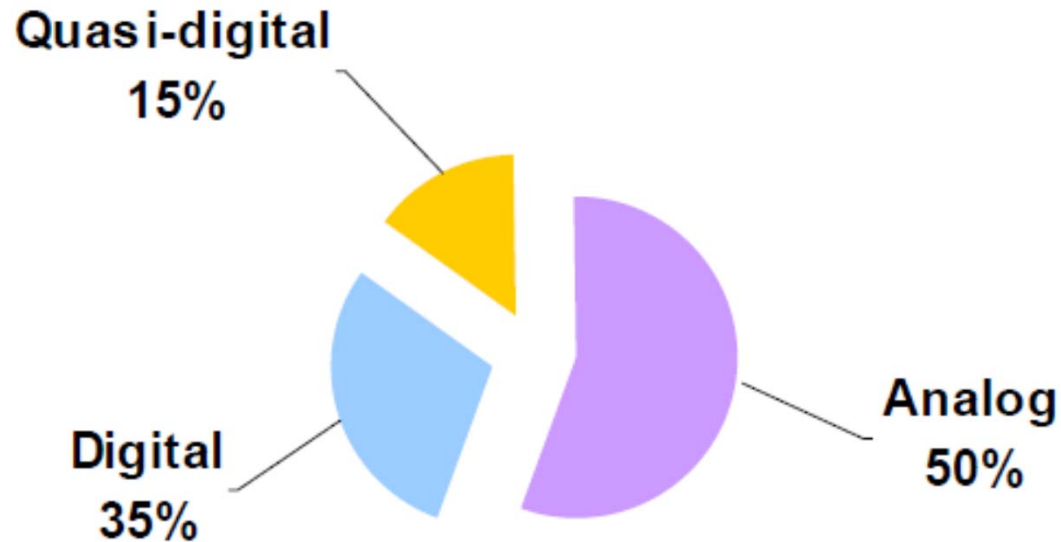
# Technological Limitations

- Below the 100 nm technology processes the design of analog and mixed-signal circuits becomes essentially more difficult
- Long development time, risk, cost, low yield rate and the need for very high volumes
- The limitation is not only an increased design effort but also a growing power consumption
- However, digital circuits becomes faster, smaller, and less power hungry

# Signal- and Data Processing Limitations

- Sensor Fusion is a complex procedure deals with analog signals
- Only limited number of sensing elements can be integrated into a combosensors

# Sensor Types Divided According to Outputs



*International Frequency Sensor Association (IFSA),  
Study, 2014*

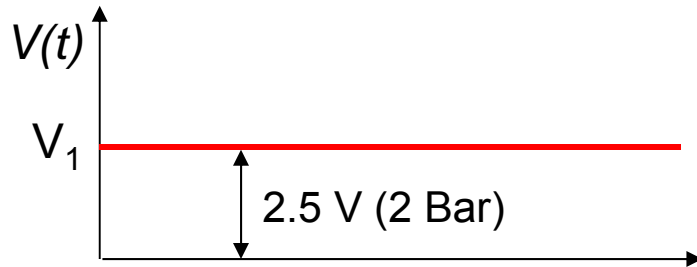
# Analog and Quasi-Digital Sensors

**Analog sensor** - sensor based on the usage of an amplitude modulation of electromagnetic processes

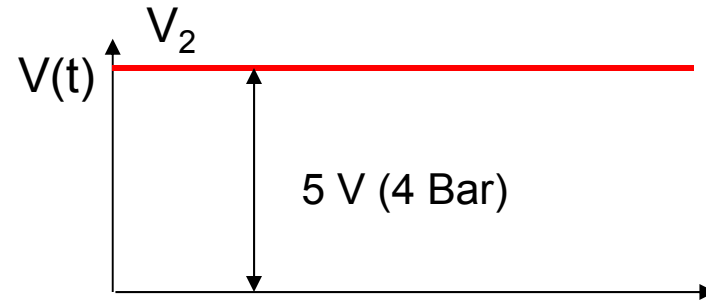
**Quasi-digital sensors** are discrete frequency-time domain sensors with frequency, period, duty-cycle, time interval, pulse number or phase shift output

Quasi-digital sensors combine a simplicity and universality that is inherent to analog devices and accuracy and noise immunity, proper to sensors with digital output

# Voltage output vs. Frequency Output

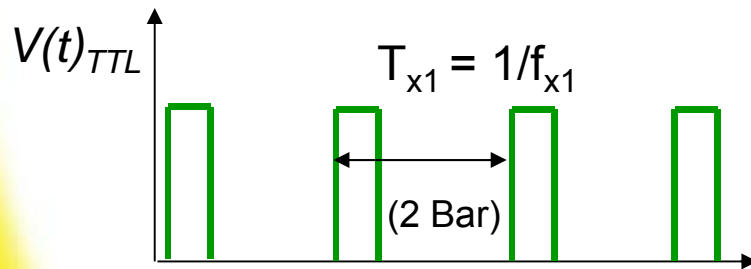


(a)

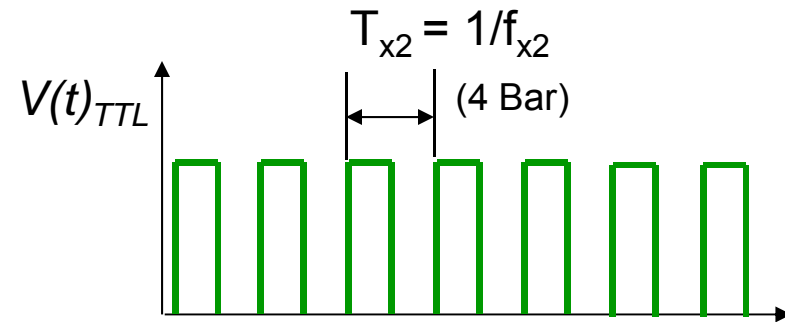


(b)

$$V_1 < V_2$$



(a)

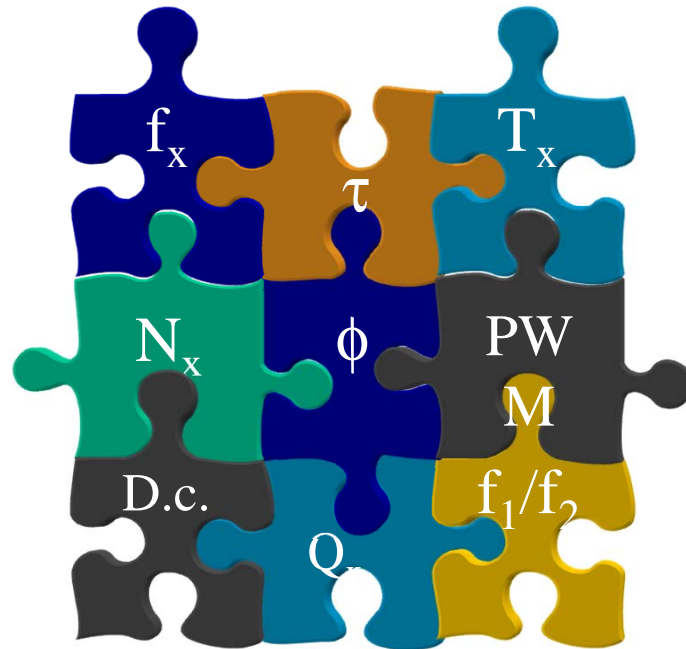


(b)

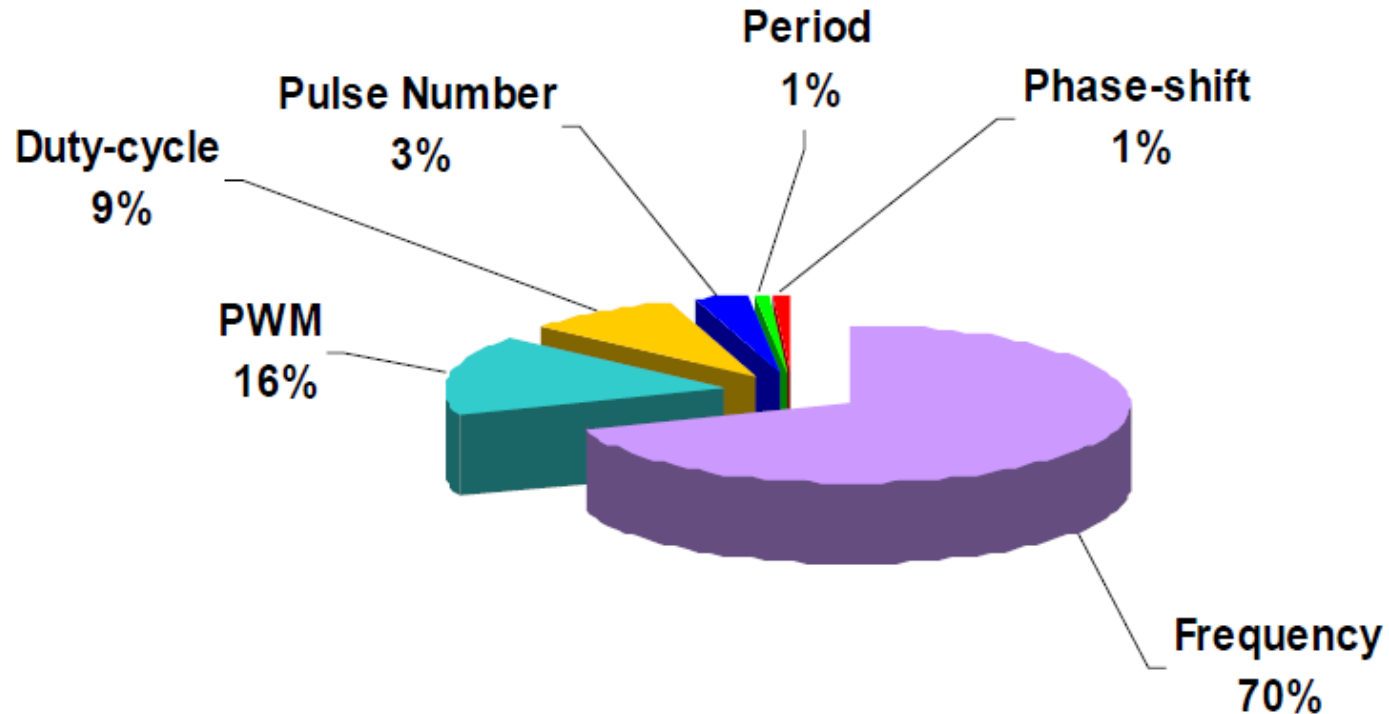
$$T_{x1} > T_{x2} , f_{x1} < f_{x2}$$

# Quasi-Digital Sensors

**Quasi-digital sensor** is a sensor with frequency, period, its ratio or difference, frequency deviation, duty-cycle (or duty-off factor), time interval, pulse width (or space) pulse number, PWM or phase shift output.

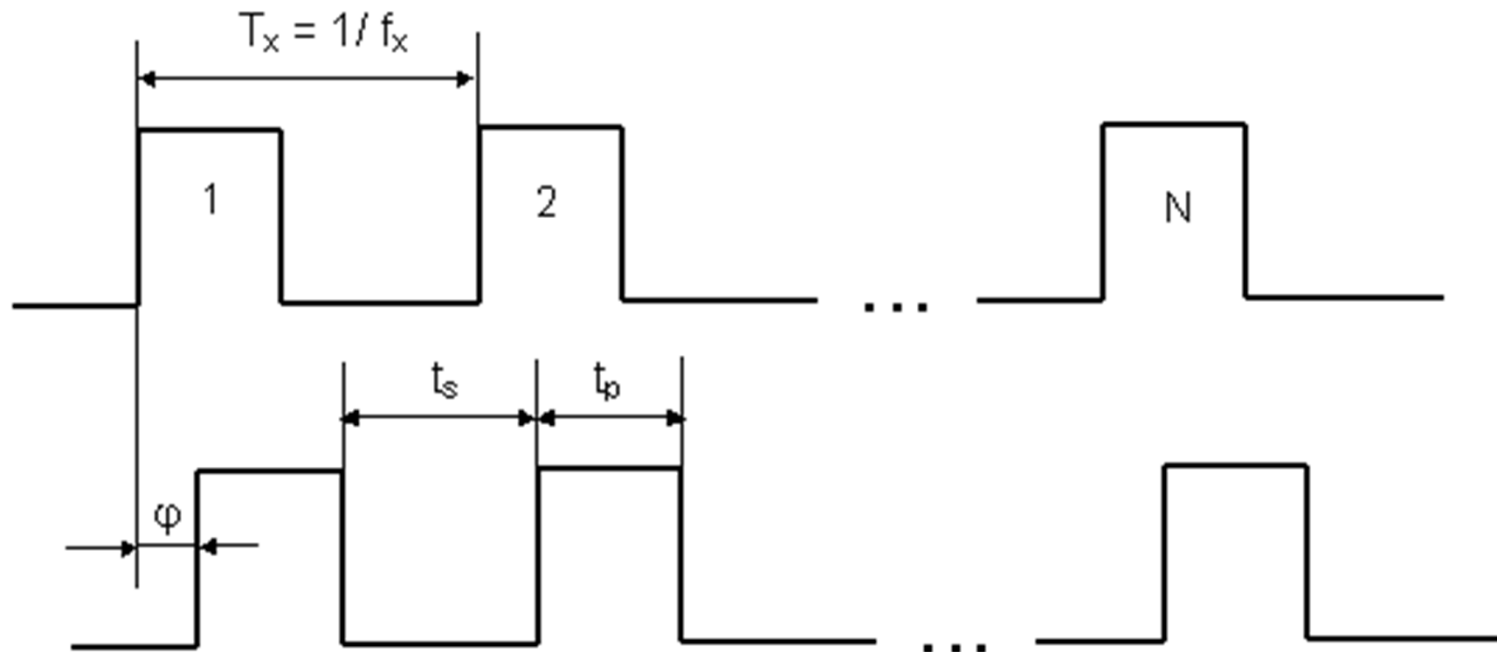


# Quasi-Digital Sensors: Types



*International Frequency Sensor Association (IFSA),  
Study 2014*

# Informative Parameters



- Duty-cycle:  $D.C. = t_p/T_x$
- Duty-off factor:  $1/D.C. = T_x/t_p$
- PWM signal:  $t_s/t_p$  ratio at  $T_x = \text{constant}$



# Digital Output Sensors

1  
0  
1  
1  
0  
1  
1  
1  
...  
1  
0

Binary  
code

- Serial interfaces RS232/485/422, USB
- Parallel interfaces (8-, 16-, 32-bits)
- Sensor buses: SPI, I2C, CAN, SMBus, LIN, etc.

1 0 1 1 1 0 0 1 0 1 } Binary code

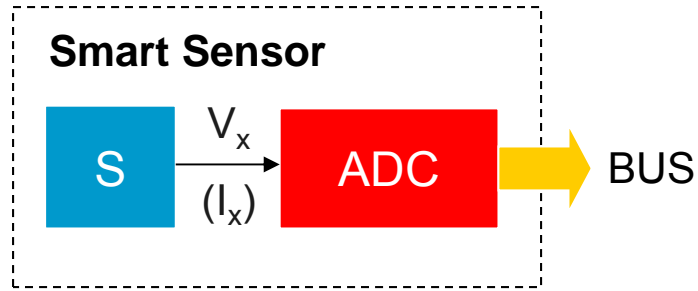
# Frequency Advantages

- High Noise Immunity
- High Power Signal
- Wide Dynamic Range
- High Reference Accuracy
- Simple Interfacing
- Simple Integration and Coding
- Multiparametricity

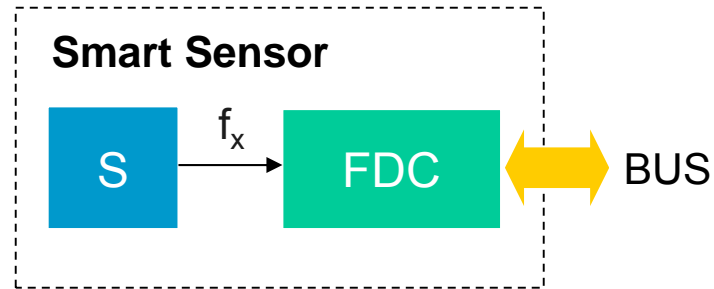
# Sensor Systems Design: Introduction

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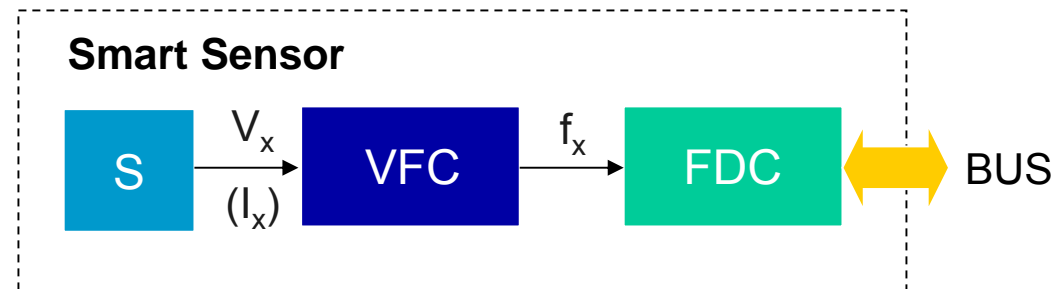
# Smart Sensors Design



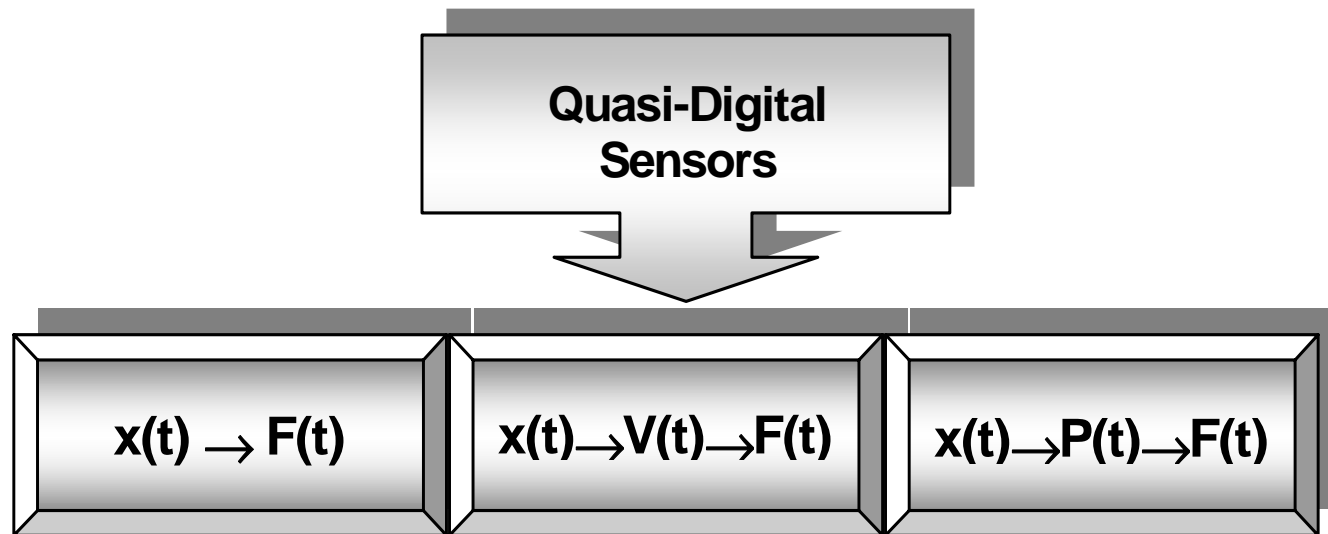
- Classical approach



- Proposed approaches

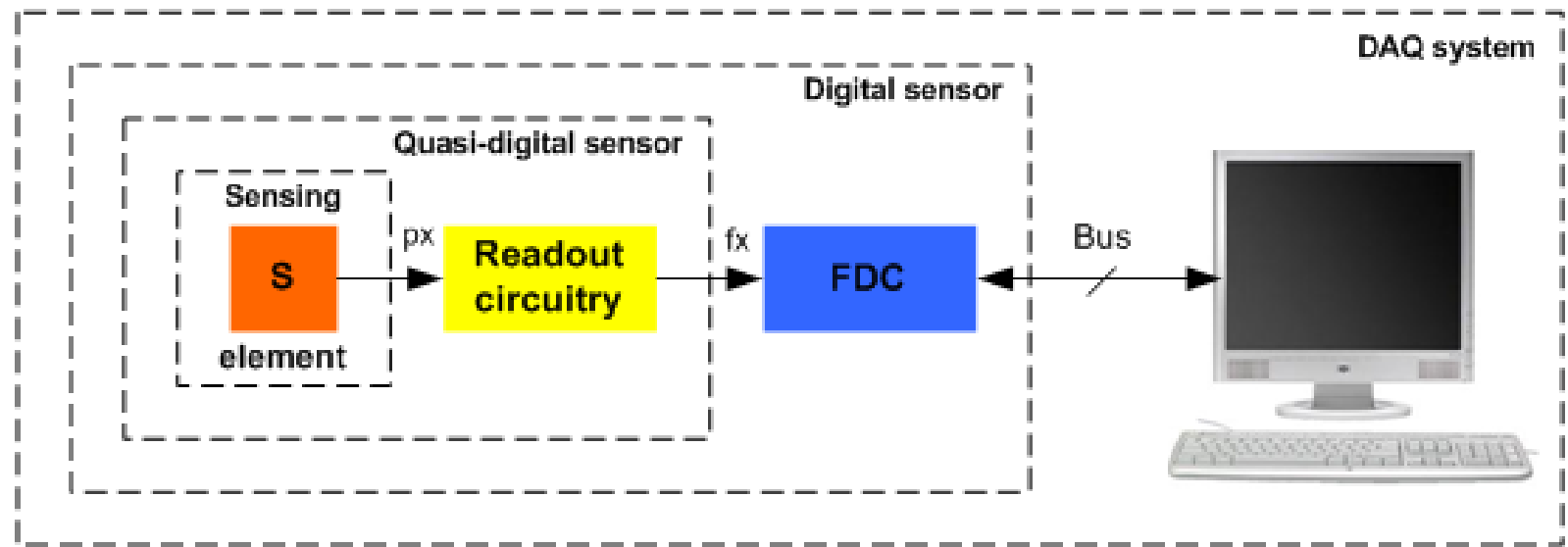


# Quasi-Digital Sensor Classification



$x(t)$ —measurand;  $F(t)$ —frequency;  $V(t)$ —voltage, proportional to the measurand;  $P(t)$ —parameter

# Quasi-Digital and Digital Sensors in System Hierarchy



# Quasi-Digital Sensors: Summary

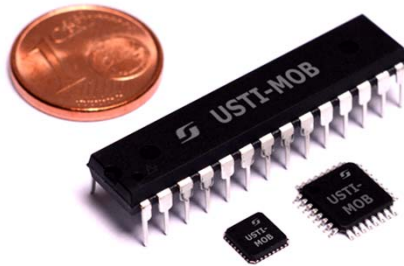
- There are many quasi-digital sensors and transducers for any physical and chemical, electrical and non electrical quantities
- Various frequency-time parameters of signals are used as informative parameters:  $f_x$ ,  $T_x$ , *D.C.*, *PWM*, *T*,  $\varphi_x$ , etc.
- The frequency range is very broad: from some parts of Hz to some MHz
- Relative error up to 0.01% and better

# Advanced Sensor Systems Design

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# USTI-MOB



- Can measure all frequency-time parameters of signal
- Low relative error up  $\pm 0.0009\%$
- Wide frequency range: 0.25 Hz to 1.95 (31) MHz
- I2C, SPI and RS232 interfaces
- 2-channel + sensing element
- Supply voltage: 1.8 V
- Active supply current  $< 0.85$  mA
- Packages: 5 x 5 mm MLF package (4 x 4 mm is coming), TQFP, PDIP

# USTI-MOB Features

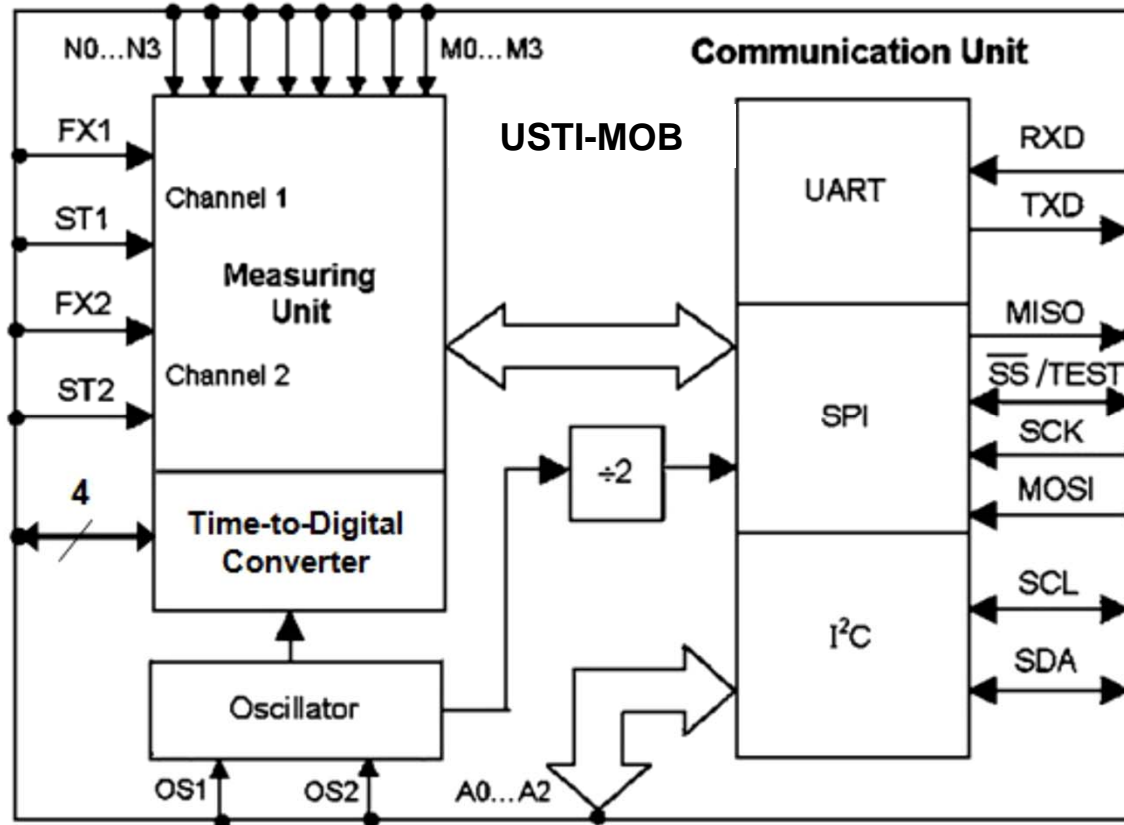


- Based on four patented methods for frequency, period, duty-cycle and phase shift measurements
- Constant relative error in all frequency range of measurements
- Non redundant conversion time
- Scalable resolution

# USTI -MOB's Measuring Modes

- Frequency,  $f_x$  [Hz]
- Period,  $T_x$  [s]
- Phase shift,  $\phi_x$  [°]
- Time interval between start – and stop-pulse [s],
- Duty-cycle, D.C. and Duty-off factor, Q
- Frequency  $f_{x1} - f_{x2}$  [Hz] and period  $T_{x1} - T_{x2}$  [s] difference
- Frequency  $f_{x1}/f_{x2}$  and period  $T_{x1}/T_{x2}$  ratio
- Rotational speed,  $n_x$  [rpm]
- Pulse width,  $t_p$  and Space interval,  $t_s$  [s]
- Pulse number (events) counting,  $N_x$
- Frequency deviation absolute DA [Hz] and relative DR [%]
- Resistance,  $R_x$  [ $\Omega$ ]
- Capacitance,  $C_x$  [F]
- Resistive bridges,  $B_x$
- Generating mode 2 MHz

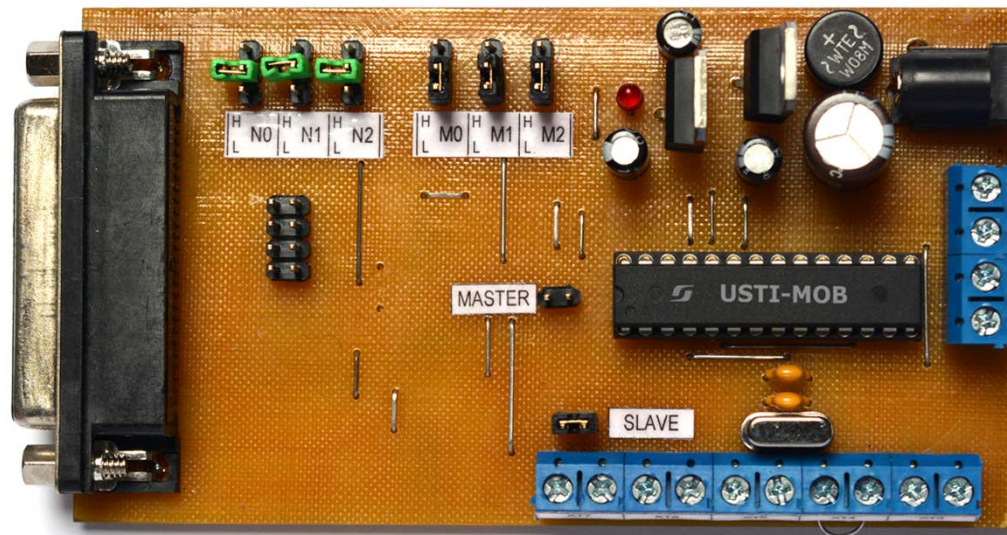
# USTI-MOB Block Diagram



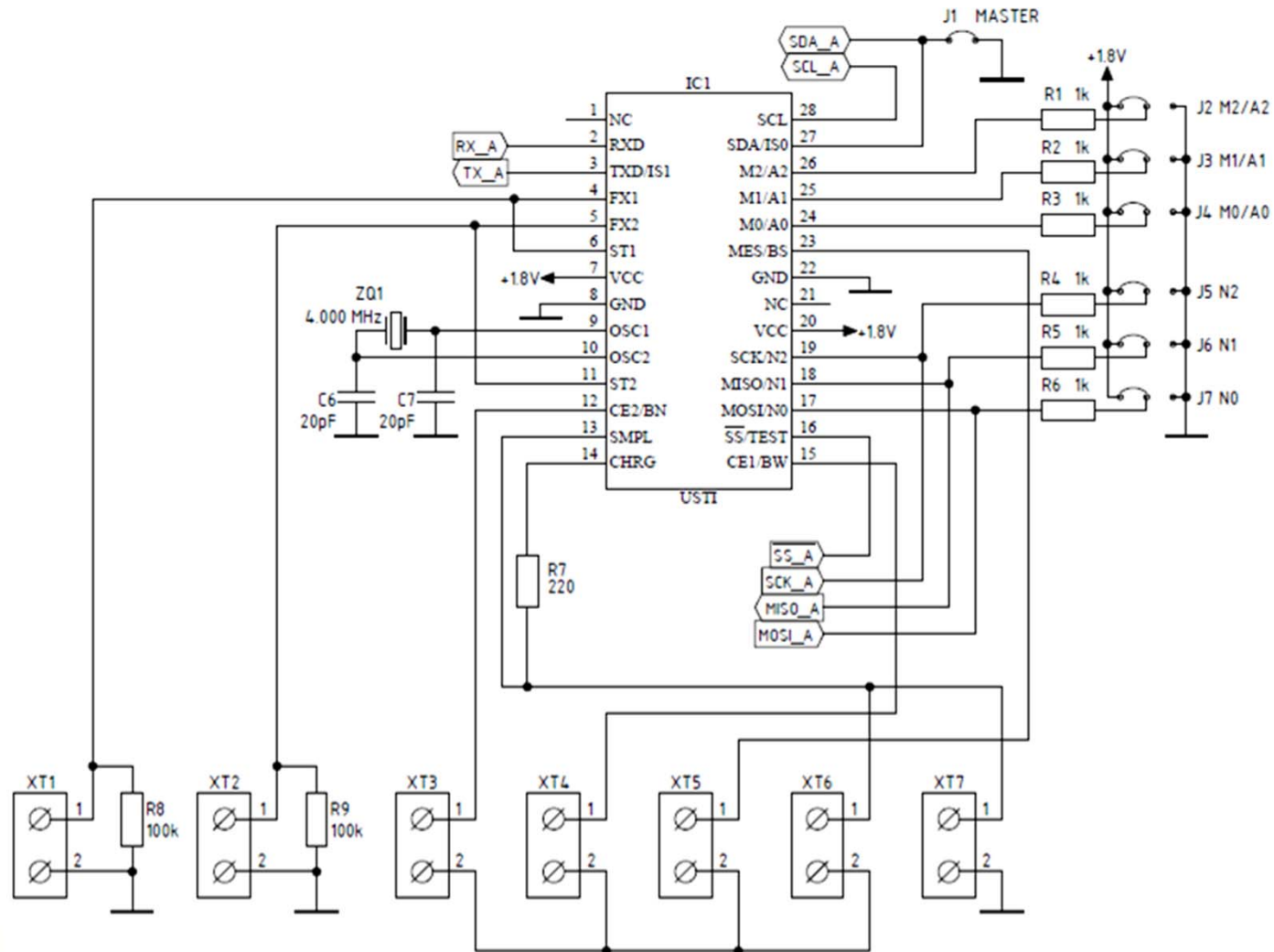
# Comparison Performances of USTI-MOB and USTI

Parameter	USTI-MOB	USTI
Programmable relative error, %	$\pm(1 \dots 0.0009)$	$\pm(1 \dots 0.0005)$
Frequency range of measurement, Hz	0.25 ... $1.95 \times 10^6$	0.05 ... $9 \times 10^6$
Reference frequency, MHz	4	20
Generating mode, MHz	2	10
Supply voltage, V	1.8	5.0
Current consumption <small>For custom design IC</small> (active mode), mA	0.85	11
Operation temperature range, °C	-40 ... +85	-40 ... +85

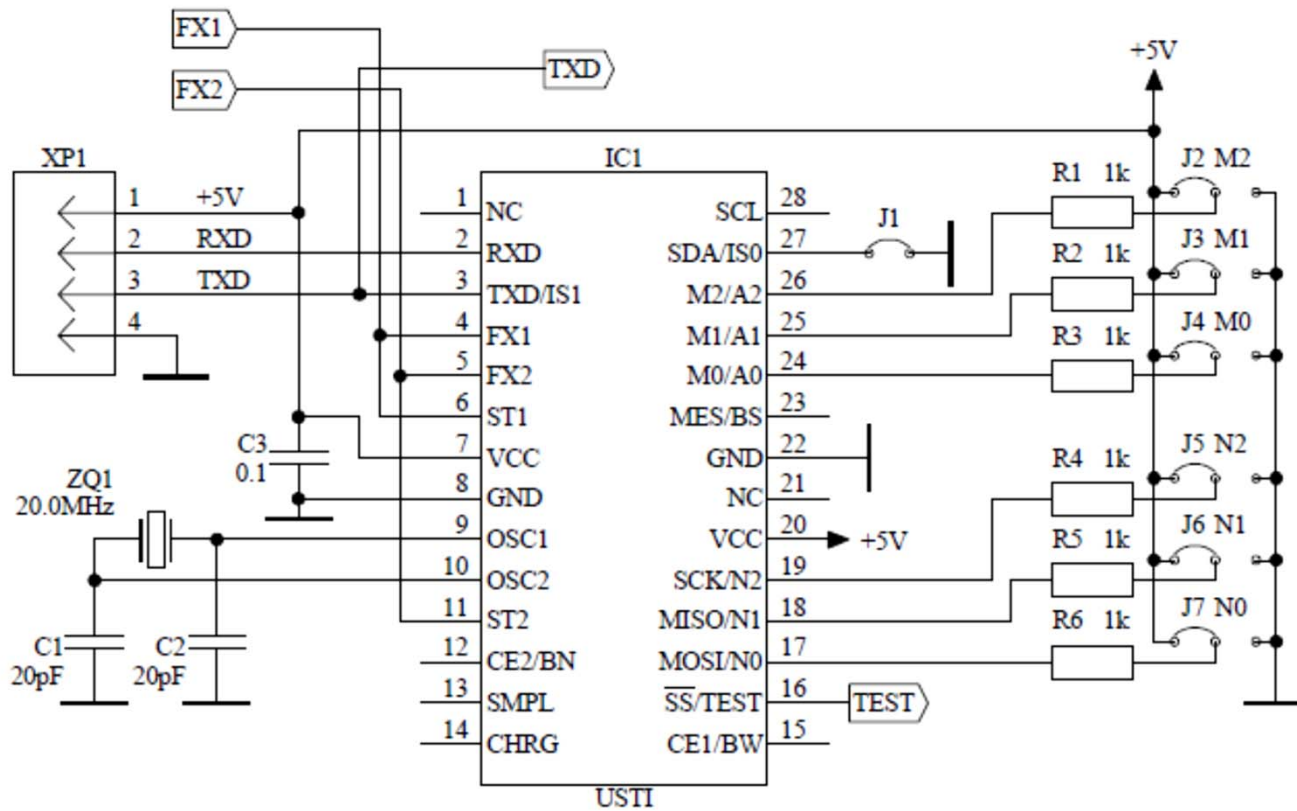
# USTI-MOB Evaluation Board Prototype



# Evaluation Board's Circuit Diagram

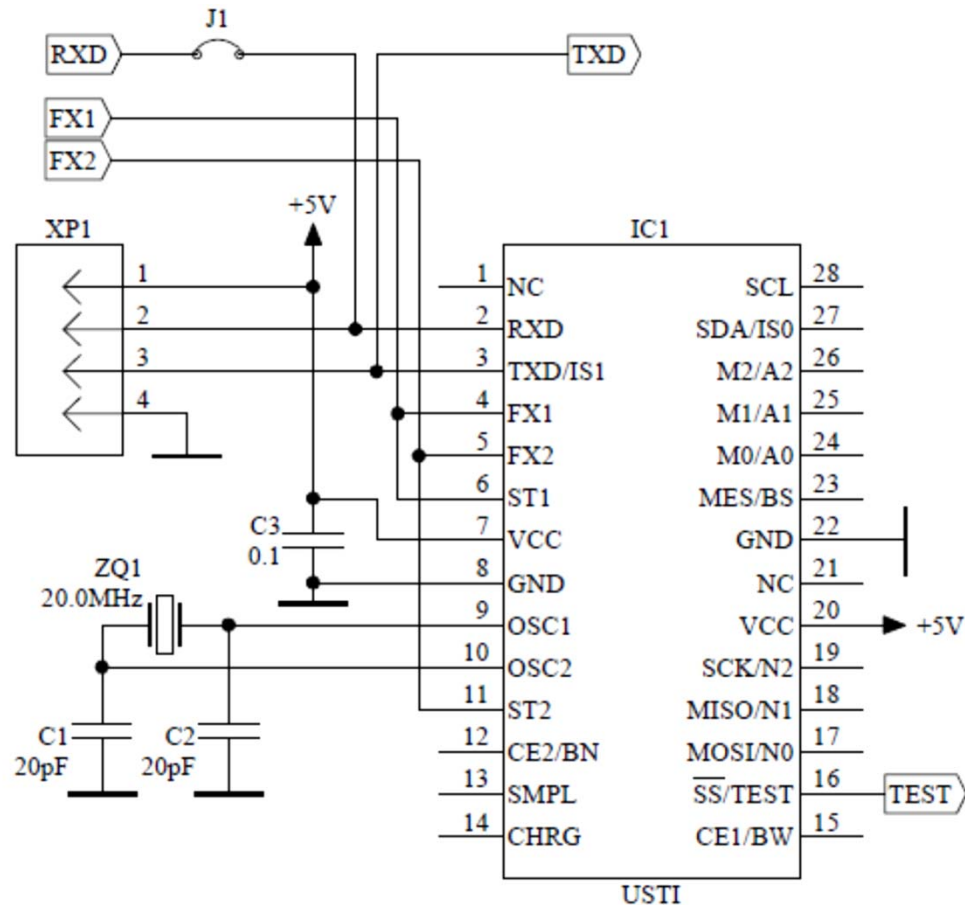


# USTI RS232 Interface (Master)

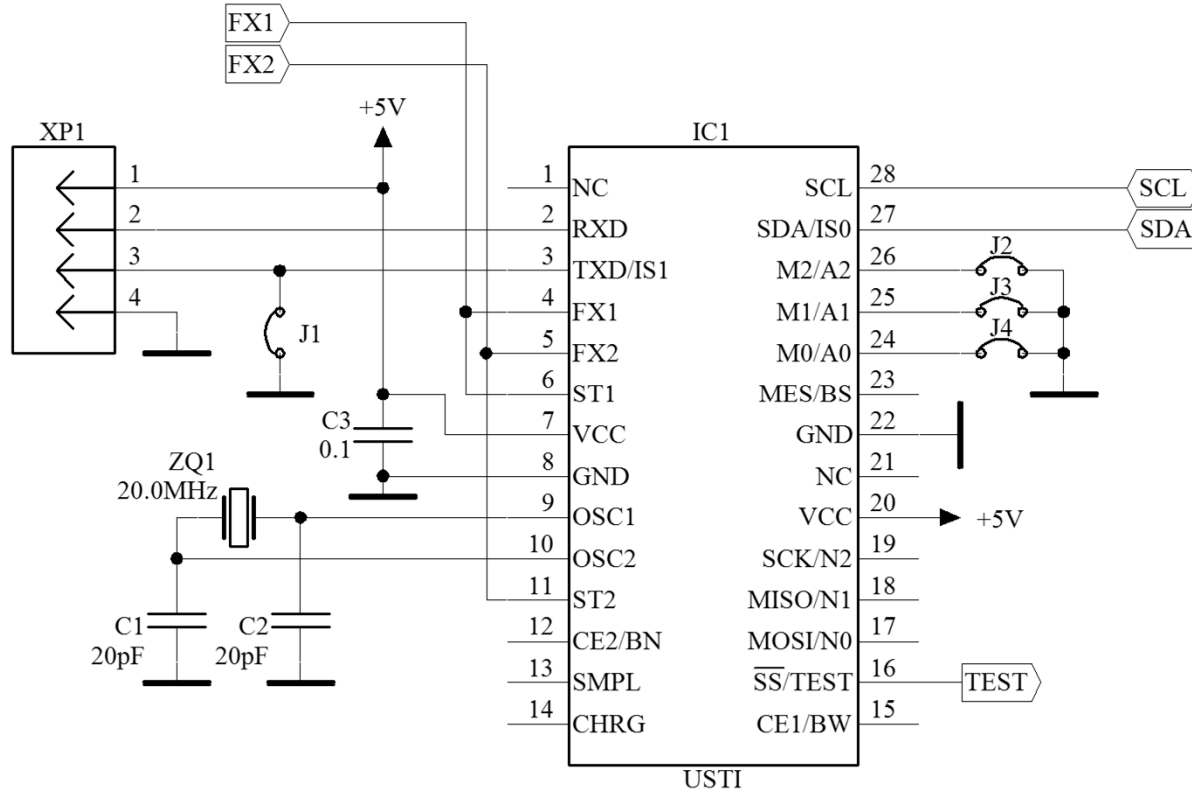




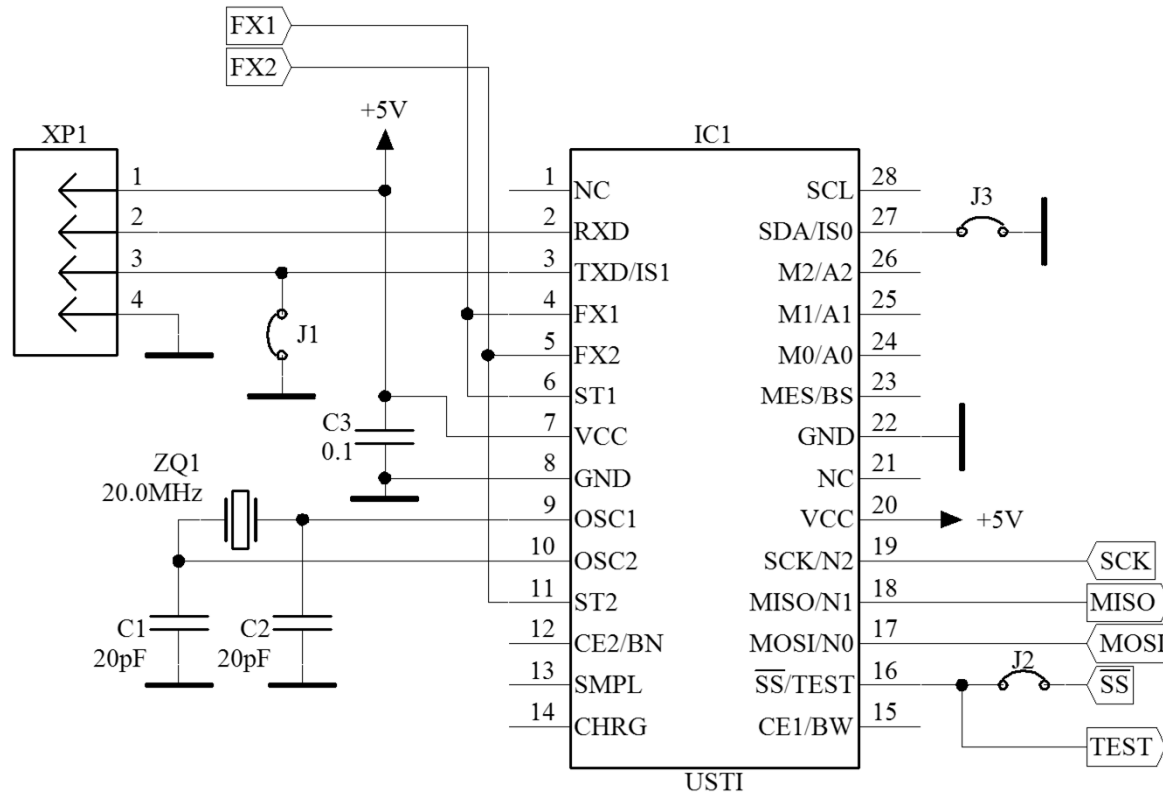
# USTI RS232 Interface (Slave)



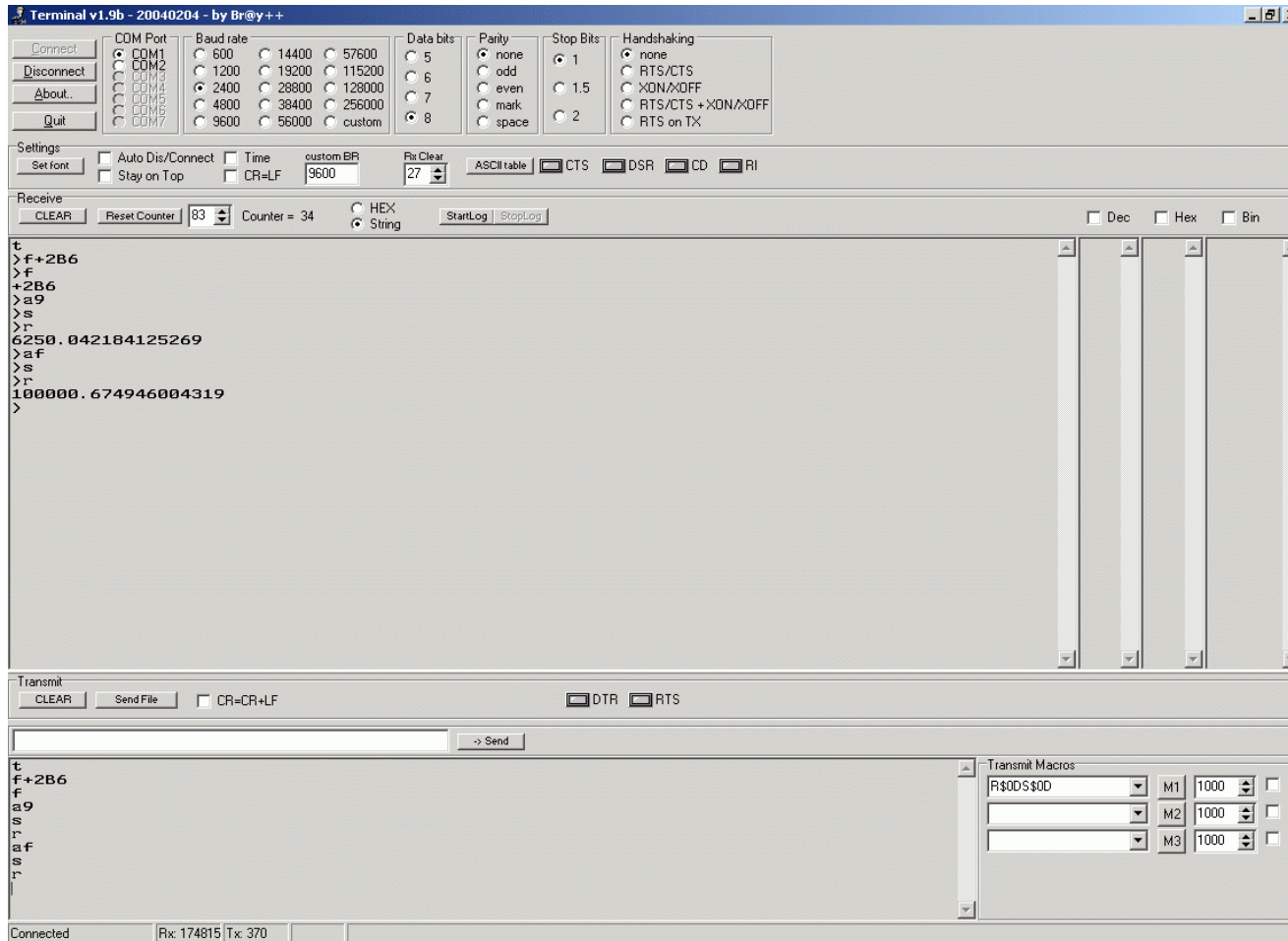
# USTI I<sup>2</sup>C Interface



# USTI SPI Interface

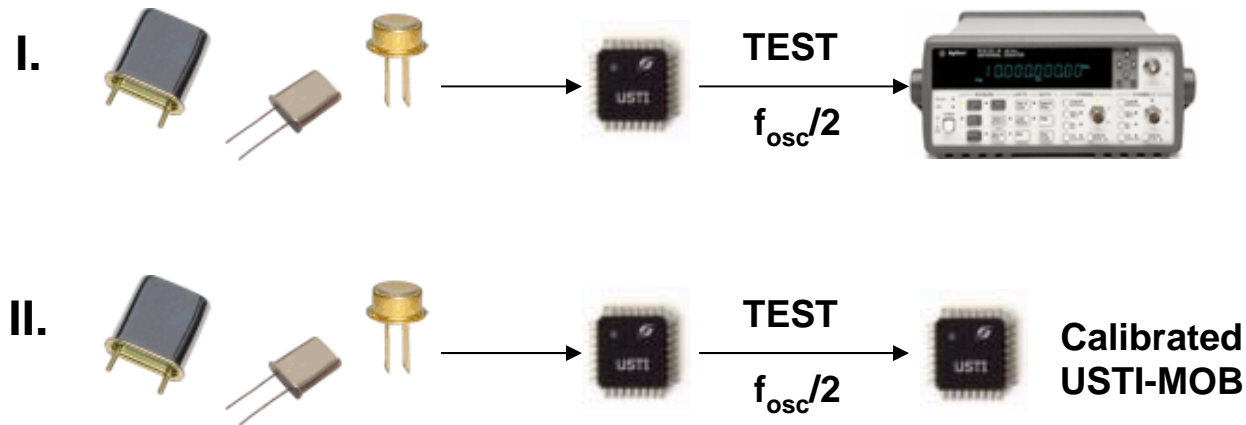


# Software (Terminal V1.9b)



# USTI-MOB Calibration Procedure

- >T ; set the IC into the calibration mode
- >F200010.82 ; correction command
- >F ; check the correction value in the IC
- 200010.82 ; returned correction factor



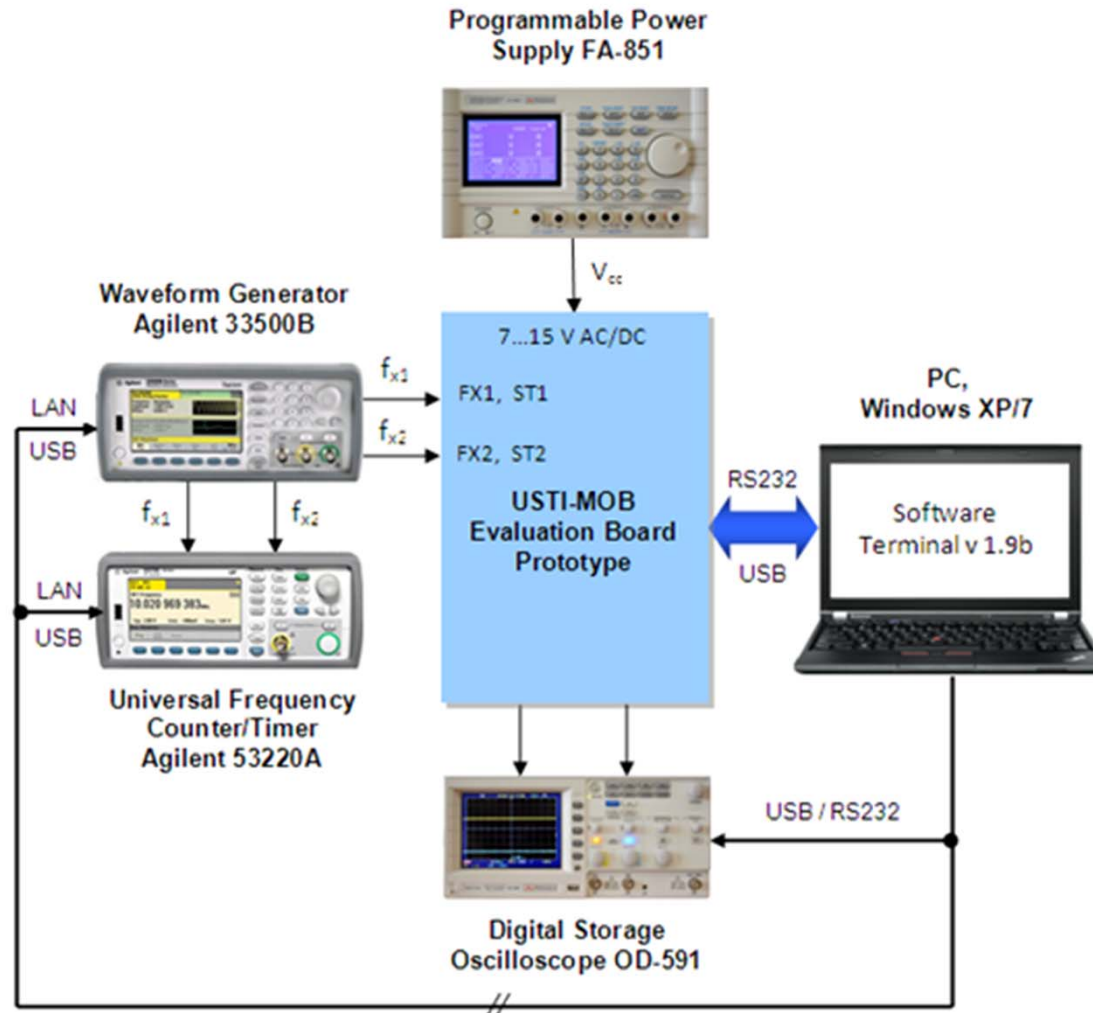
# Temperature Drift Calibration

- The USTI-MOB is working in the industrial temperature range:  
– 40° C...+ 85° C
- Temperature drift error can be eliminated by the calibration in an appropriate working temperature ranges

# No Calibrate If:

- Relative error of measurement  $> \pm 0.026\%$
- Use a precision temperature-compensated integrated generator with  $\pm 1$  ppm frequency stability over the  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$
- In this case a custom designed USTI-MOB should be ordered

# Experimental Set-up: $f_x$ , $T_x$ , $t_x$ , its Ratio and Difference

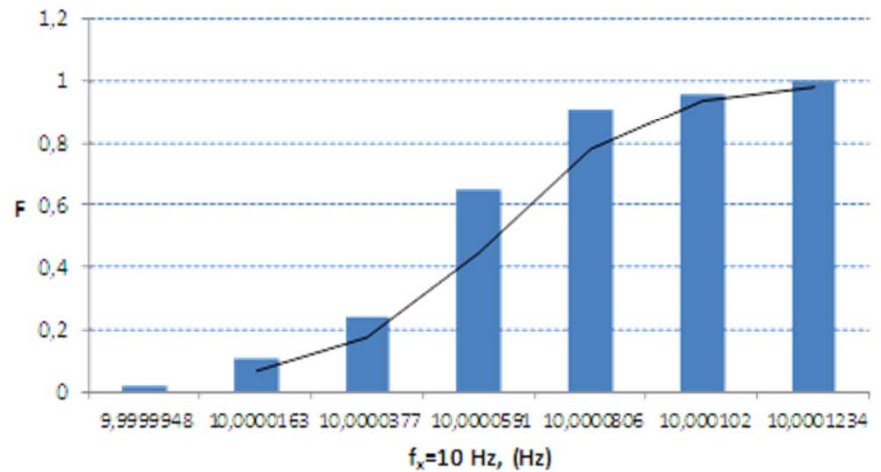
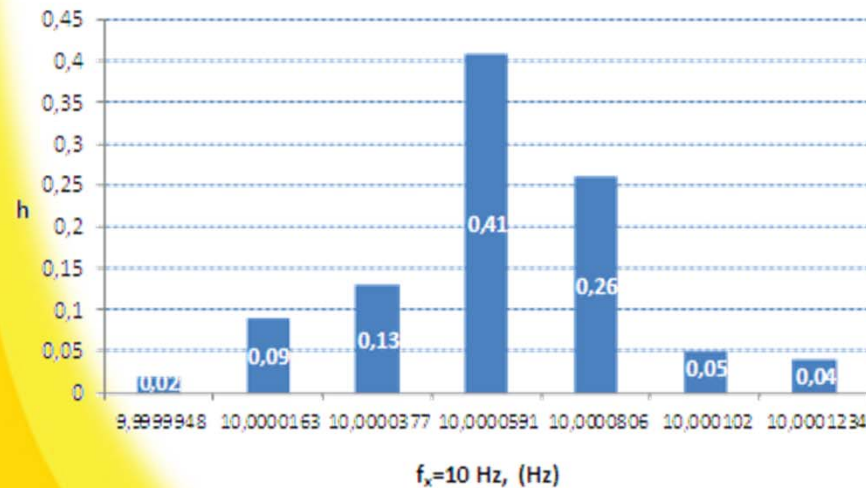
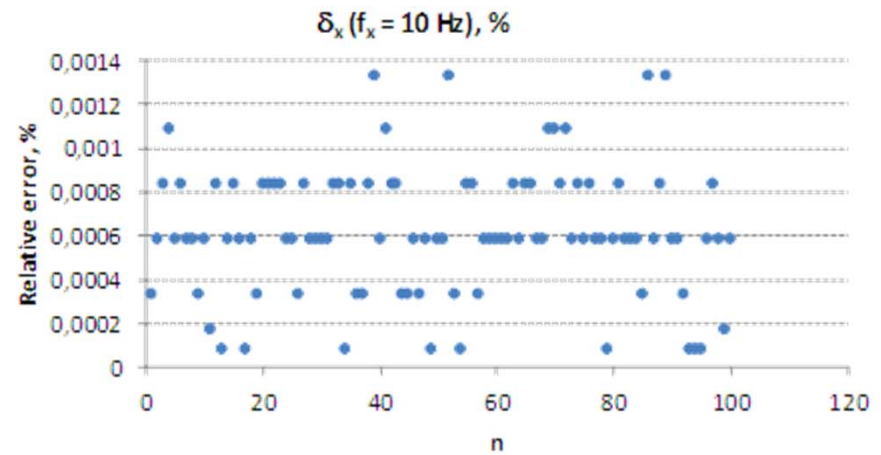
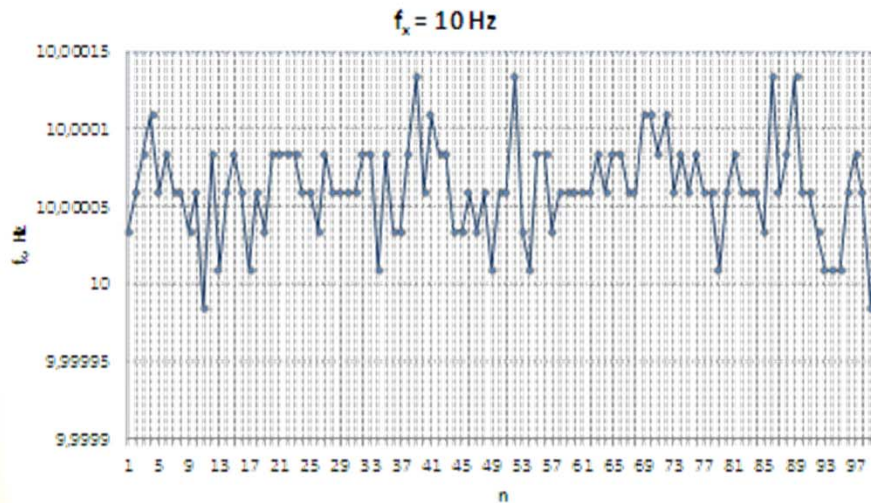




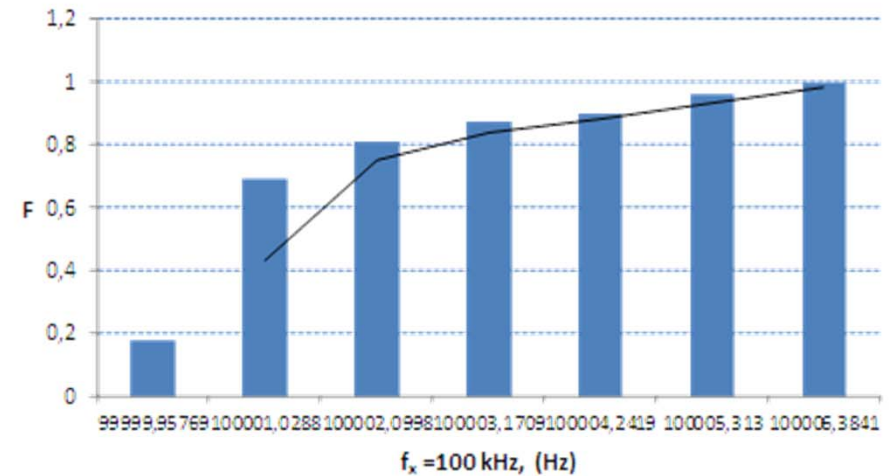
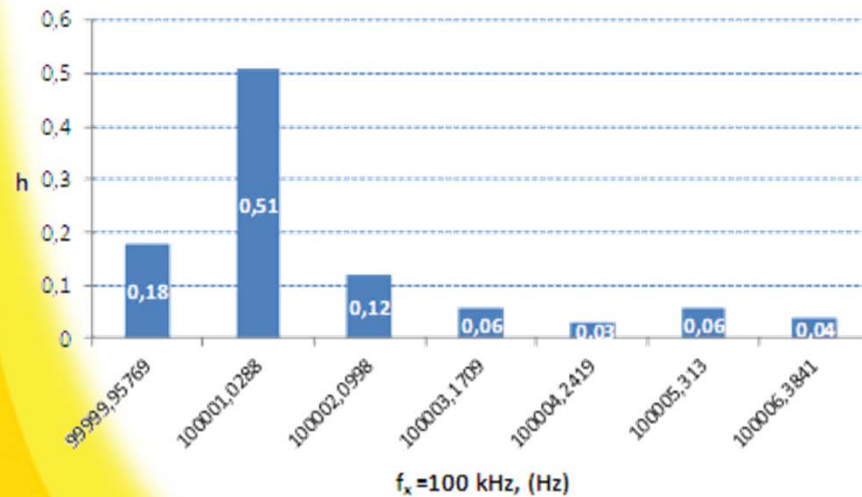
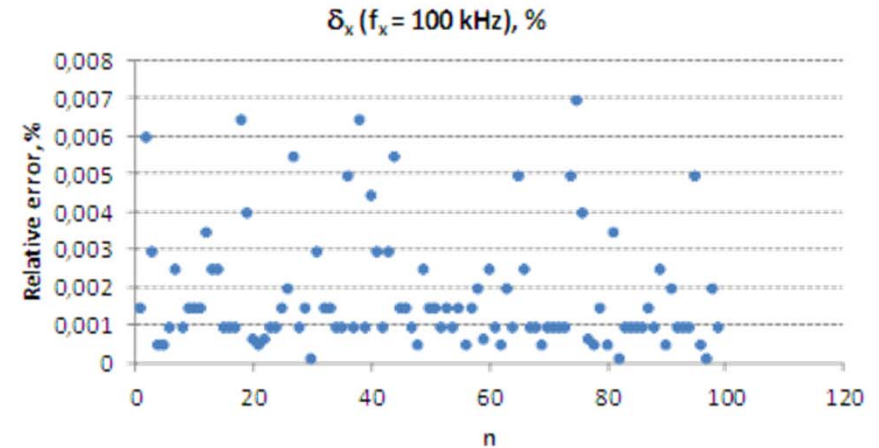
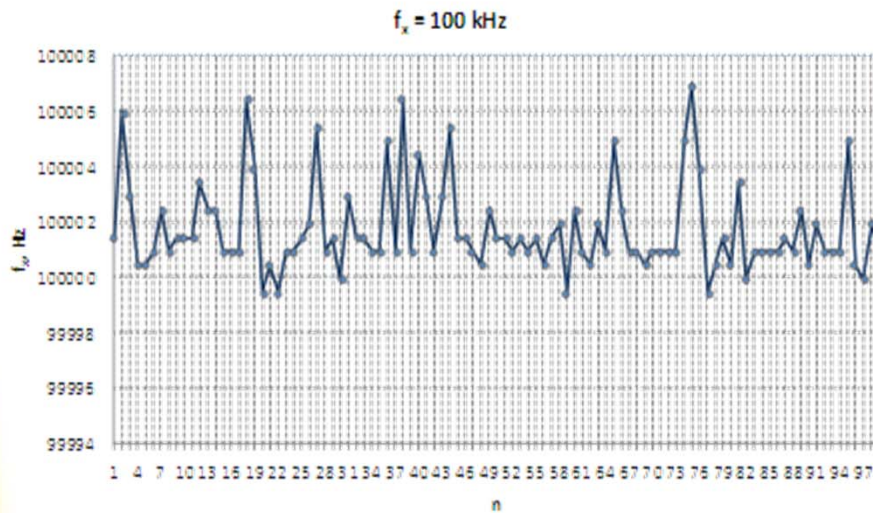
# Measuring Equipment



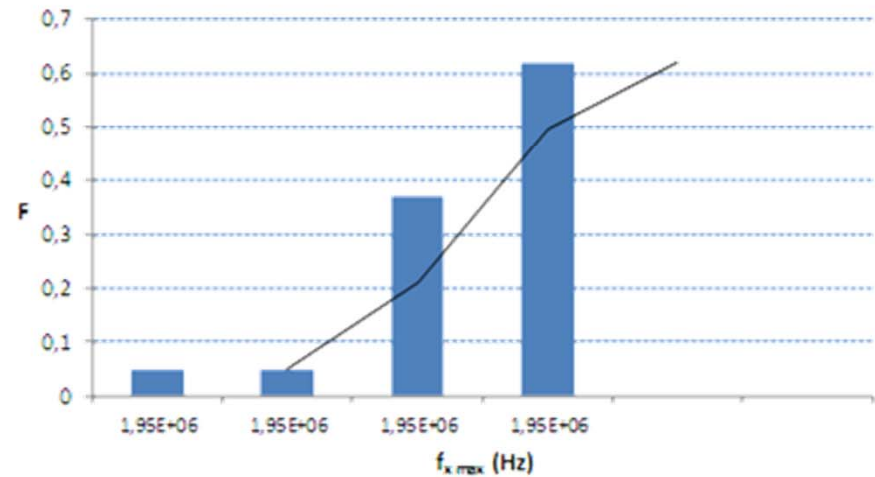
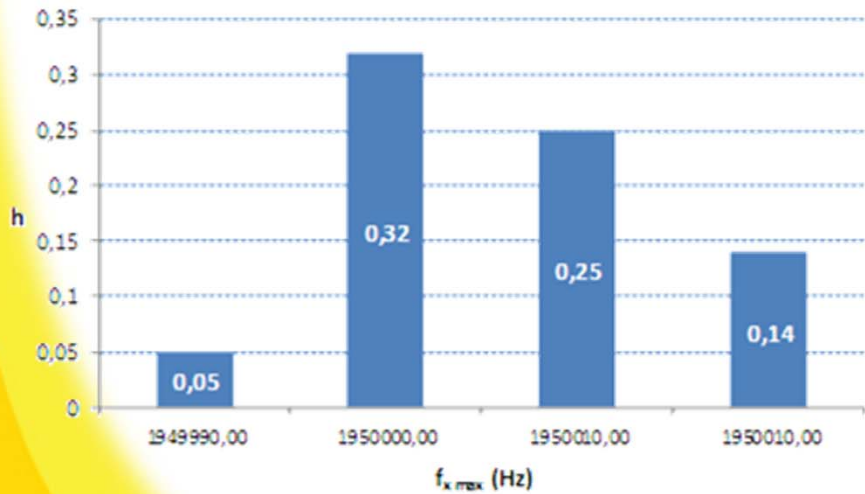
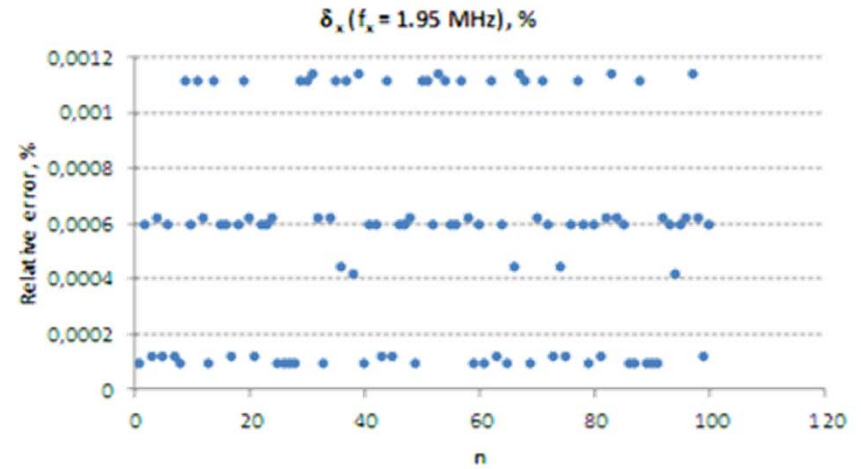
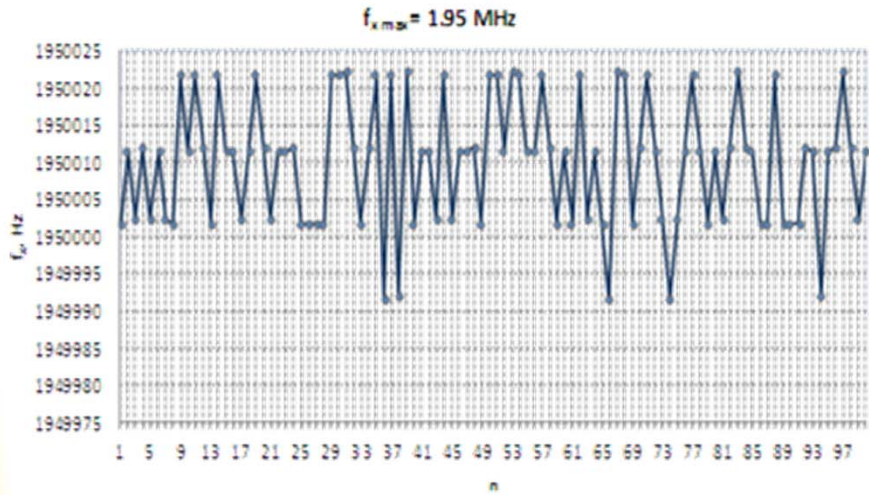
# Results of 10 Hz Measurements



# Results of 100 Hz Measurements

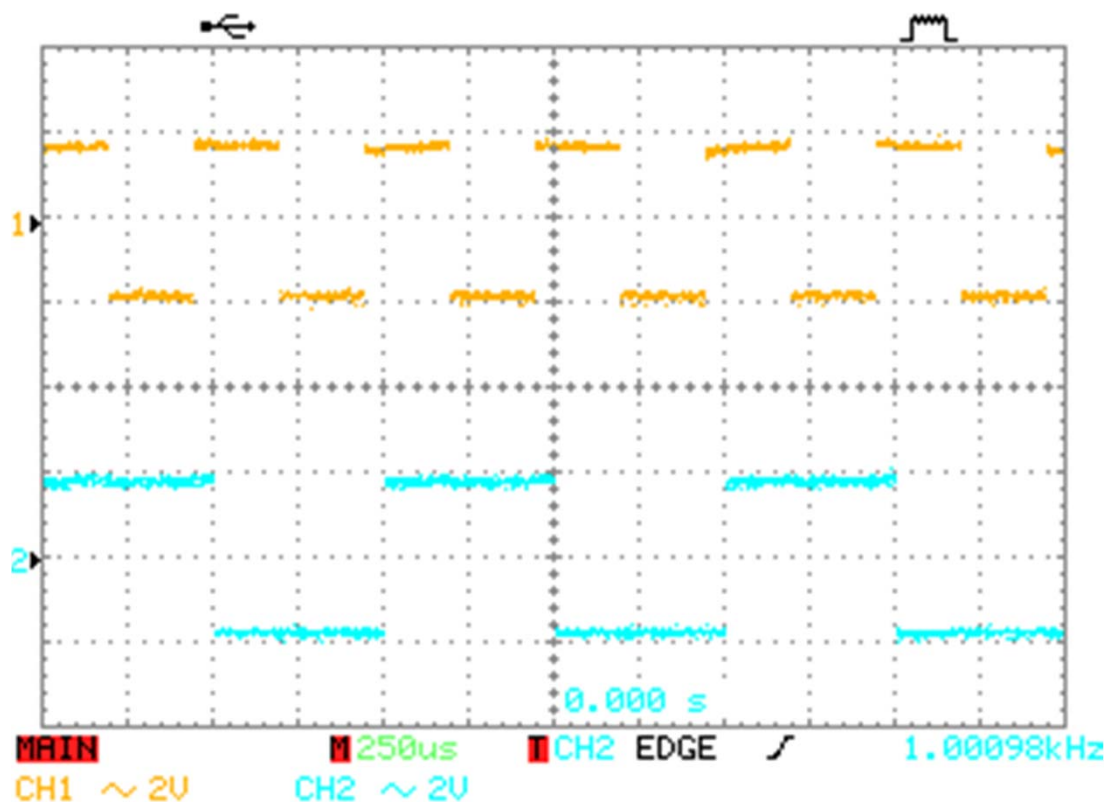


# Results of 1.95 MHz Measurements

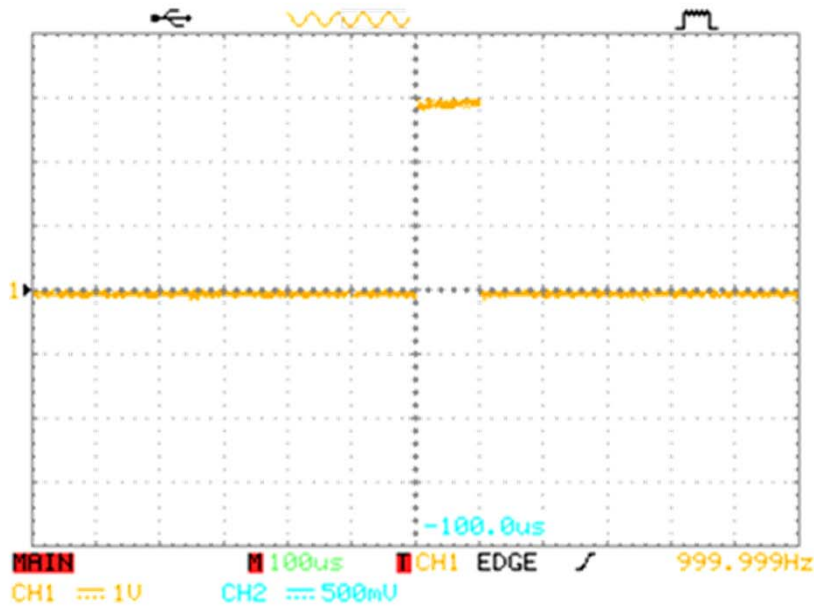


# Frequency (Period) Ratio

Measurement:  $f_{x1}/f_{x2}$  ( $T_{x1}/T_{x2}$ )



# Pulse Width Measurement, $t_x$



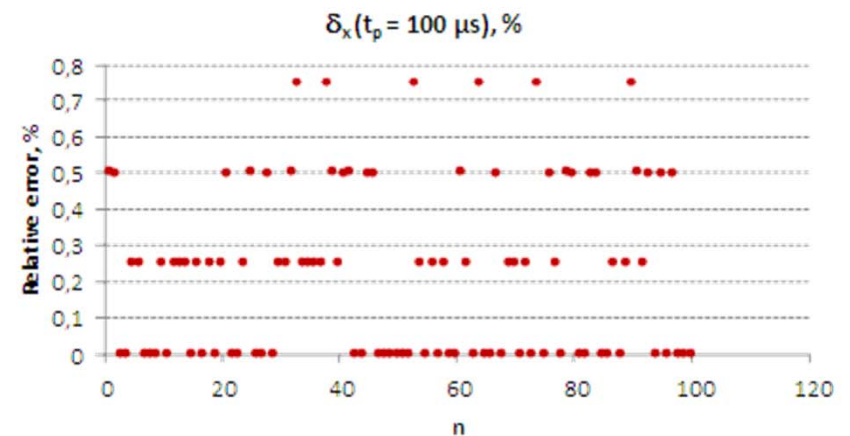
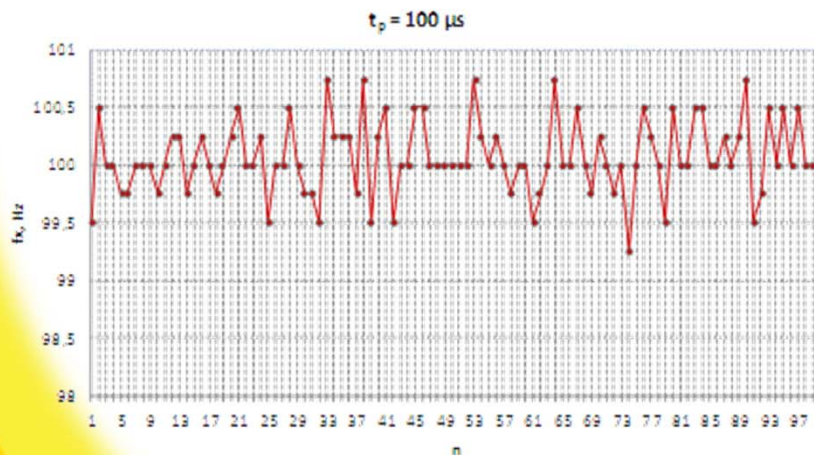
$\Pi$  50%  
 AC 1M $\Omega$  5V

**CH 1 Pos Pulse Width** Gate  
**+100.000 112μsec**

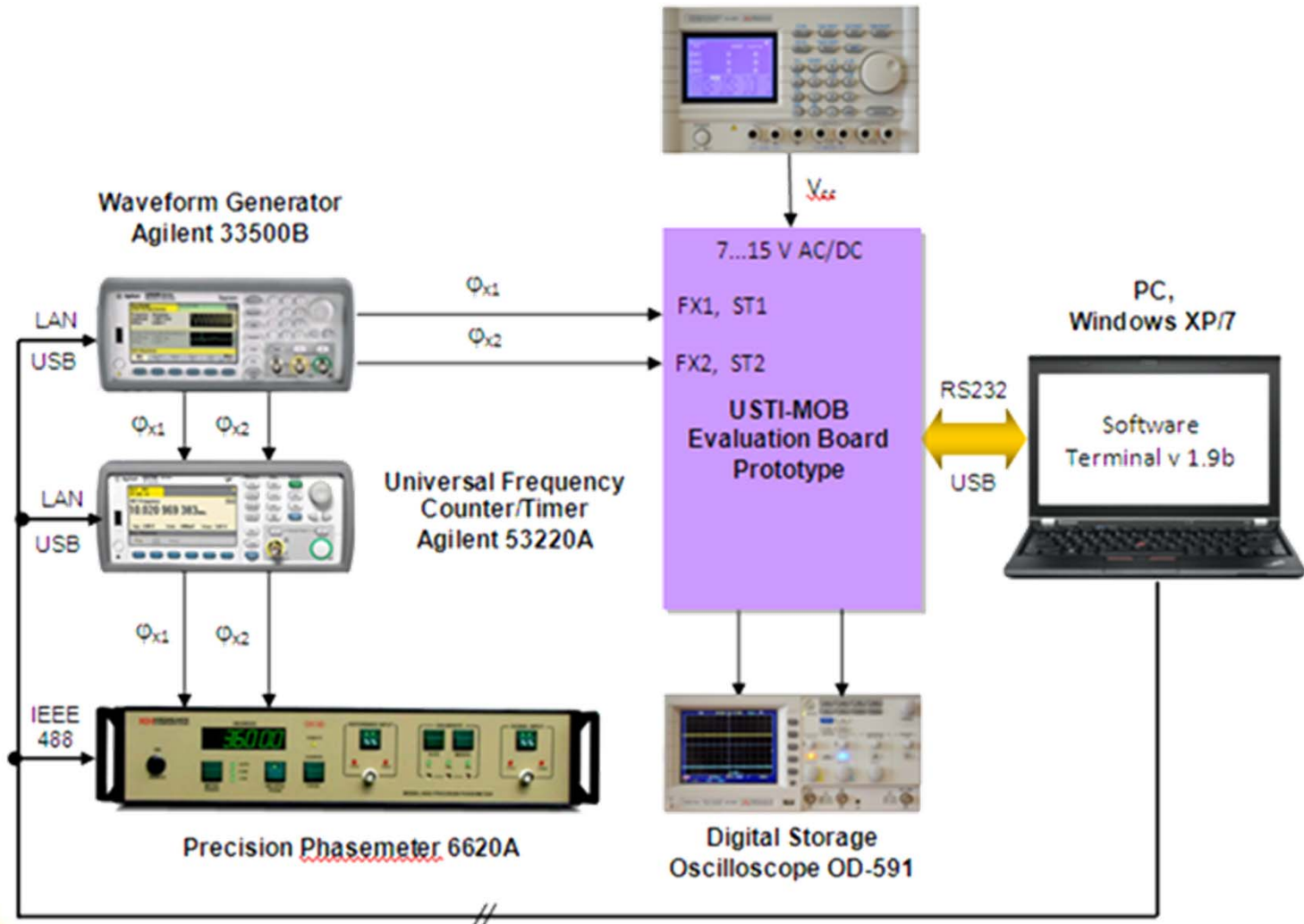
Mean: +100.000 104μsec	Max: +100.000 336μsec
StdDev: +26psec	Min: +99.999 902μsec
Count: 16 989	Pk to Pk: +435psec

**Math** Math On

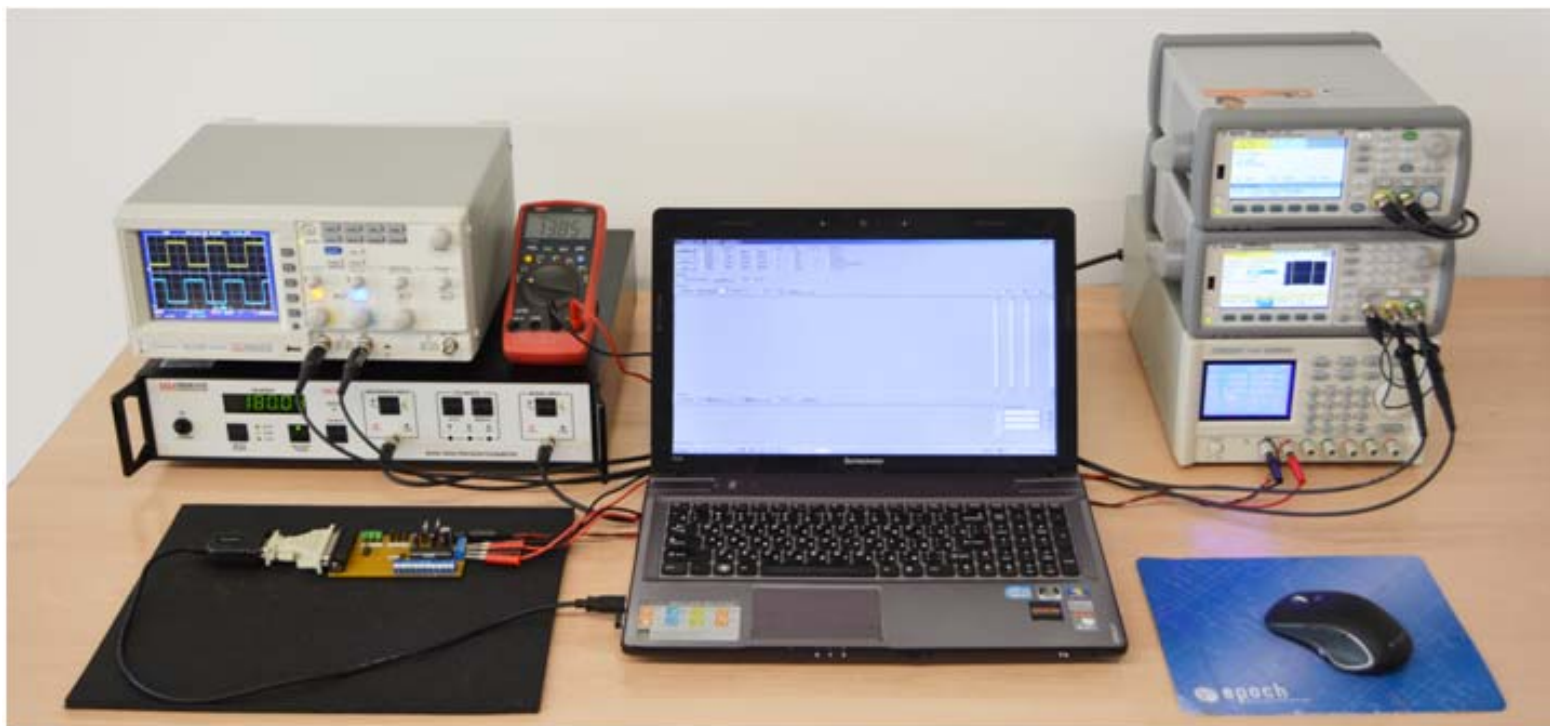
**Statistics**  
 Off  On Reset Stats



# Experimental Set-up for Phase Angle Measurements, $\phi_x$

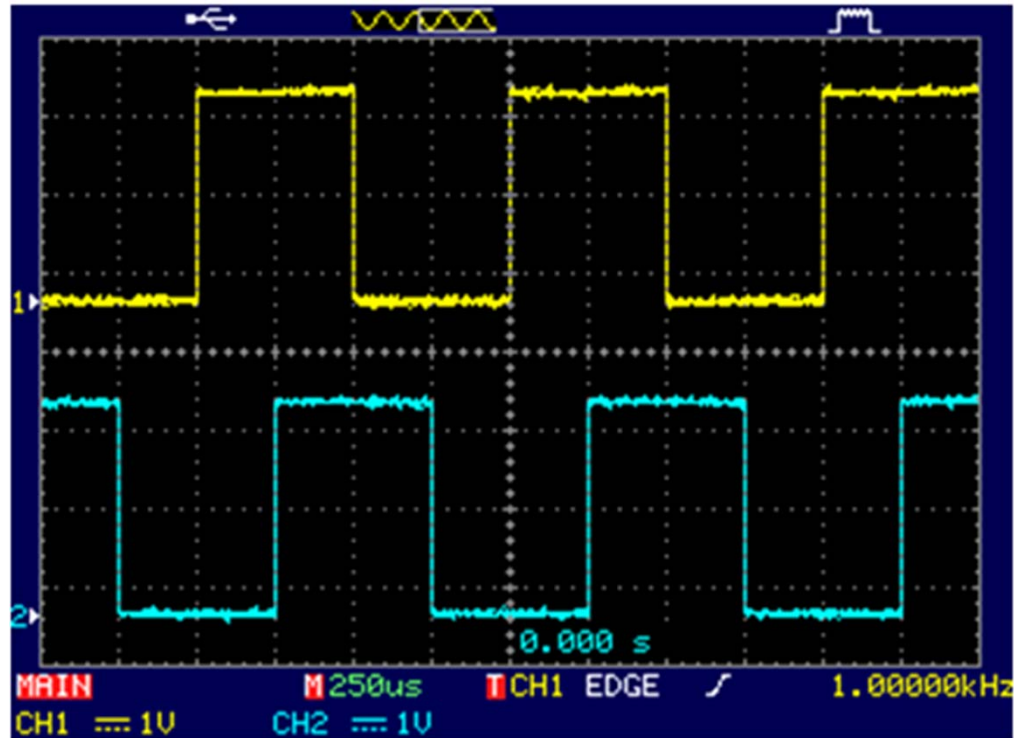


# Measuring Equipment for $\phi_x$ Measurement

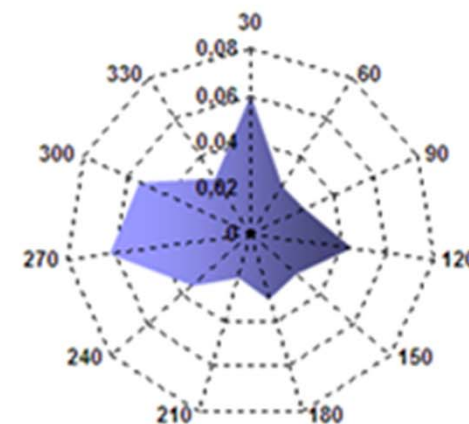
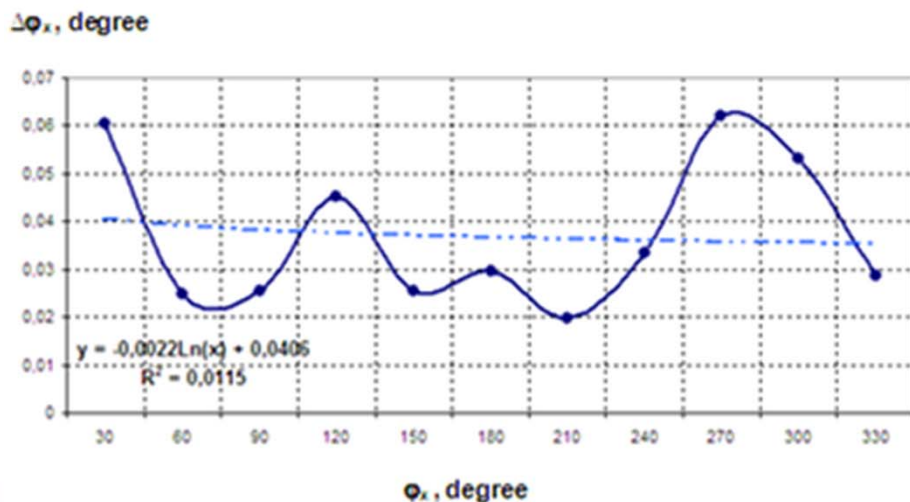
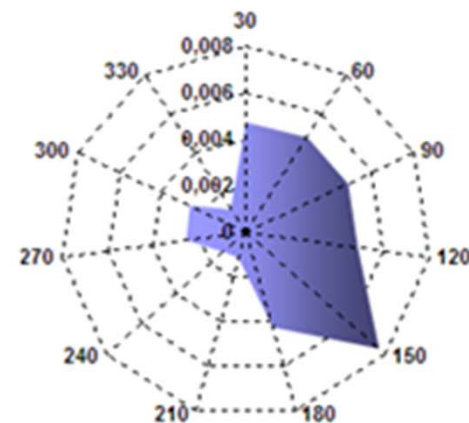
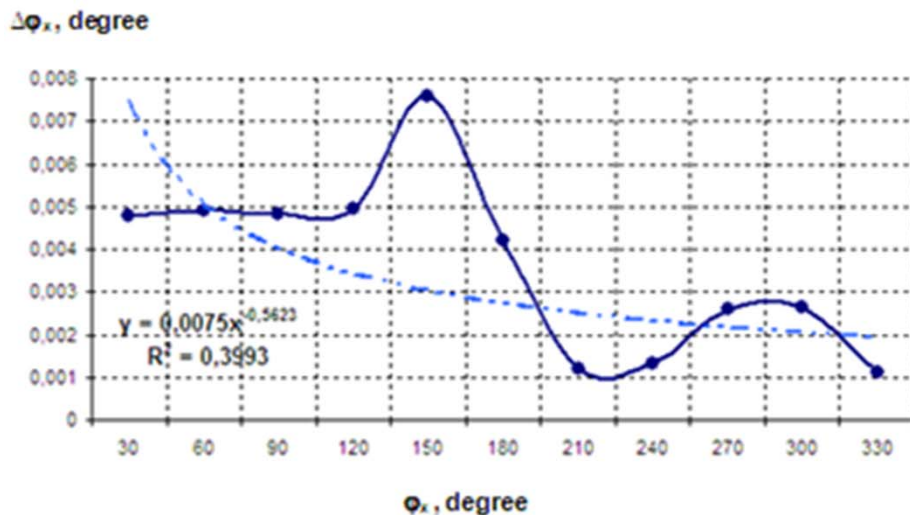




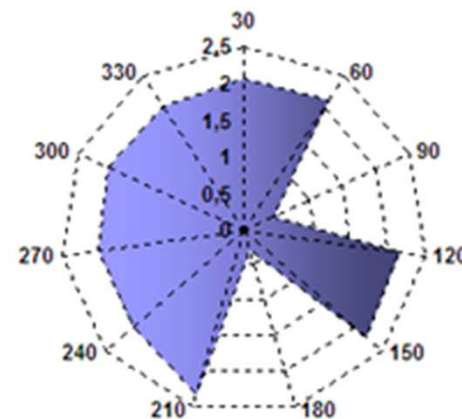
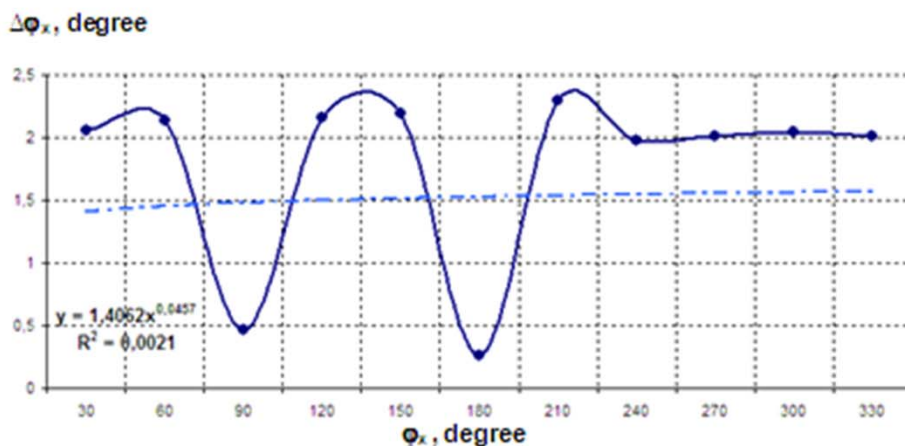
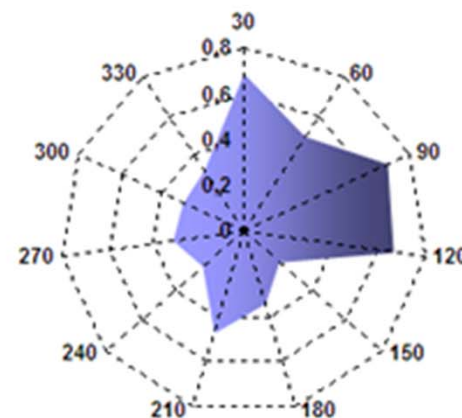
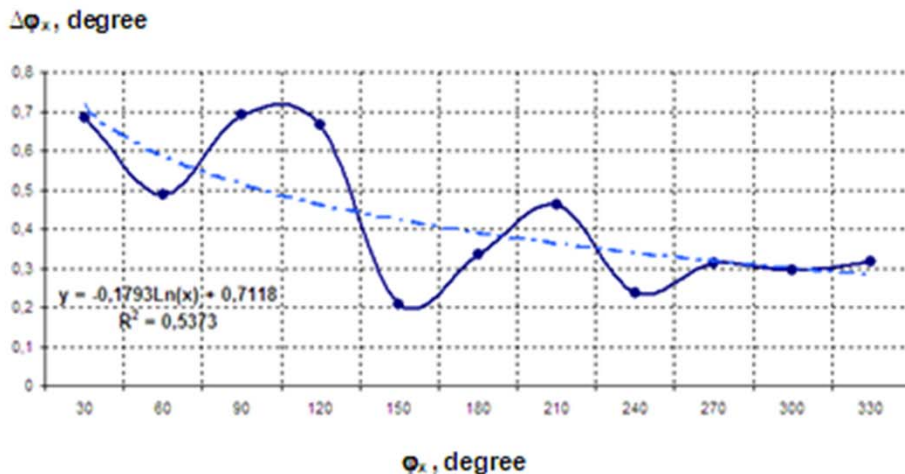
# Rectangular Waveform Signals ( $120^\circ \varphi_x$ at 1 kHz)



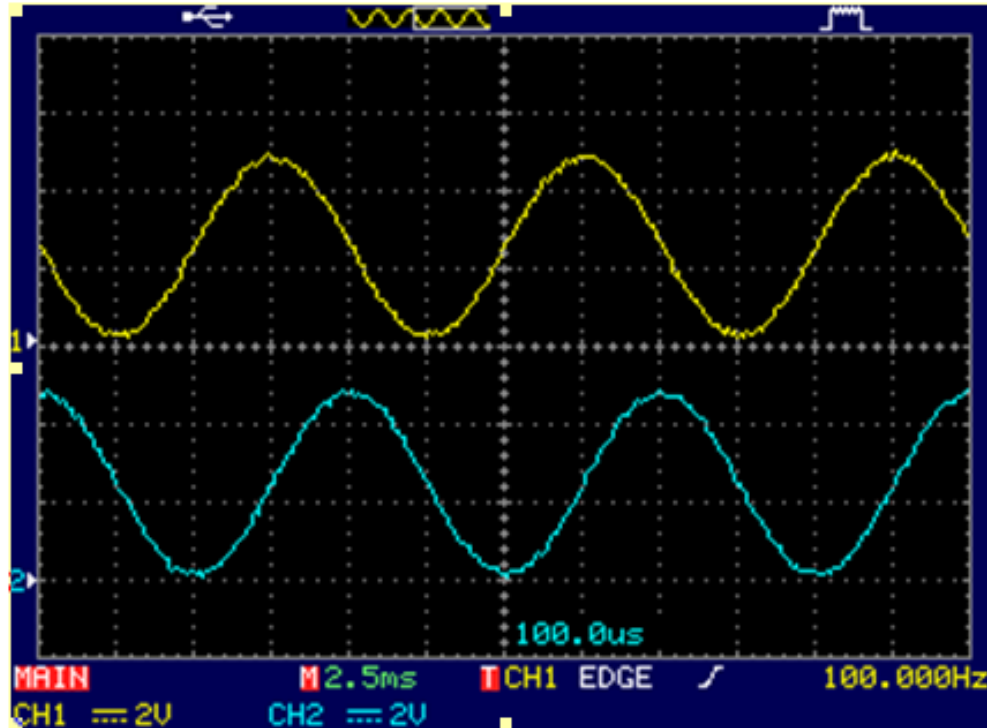
# Phase Shift Measurement Absolute Error at 10 Hz and 100 Hz



# Phase Shift Measurement Absolute Error at 1 kHz and 4 kHz

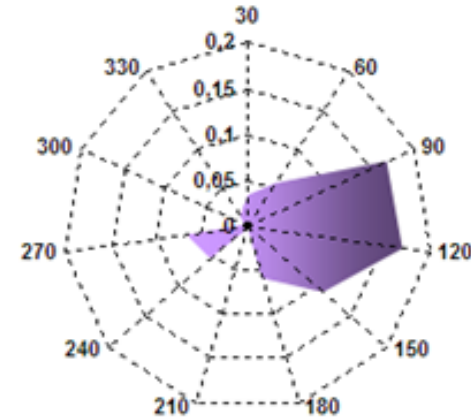
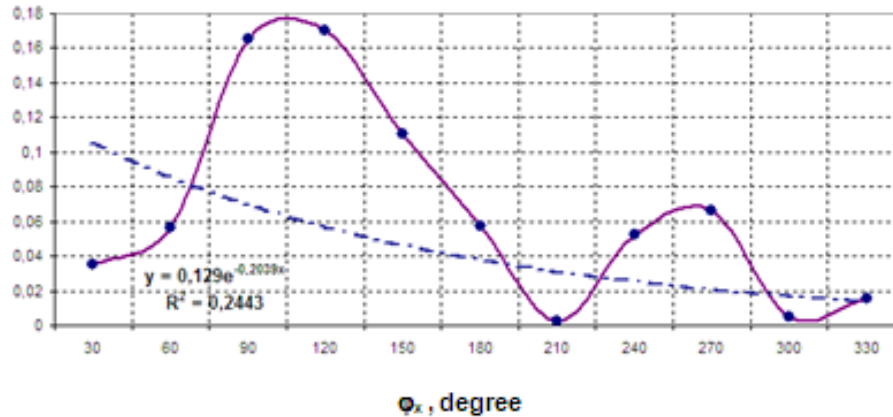


# Sine Waveform Signals ( $90^\circ \phi_x$ at 100 Hz)

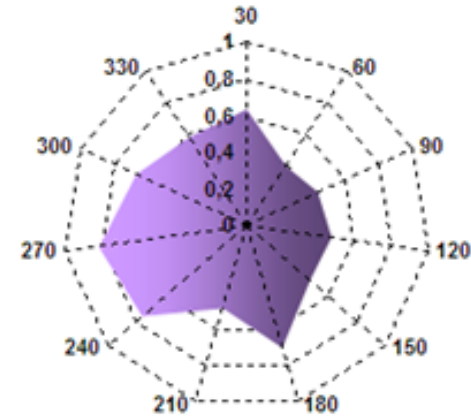
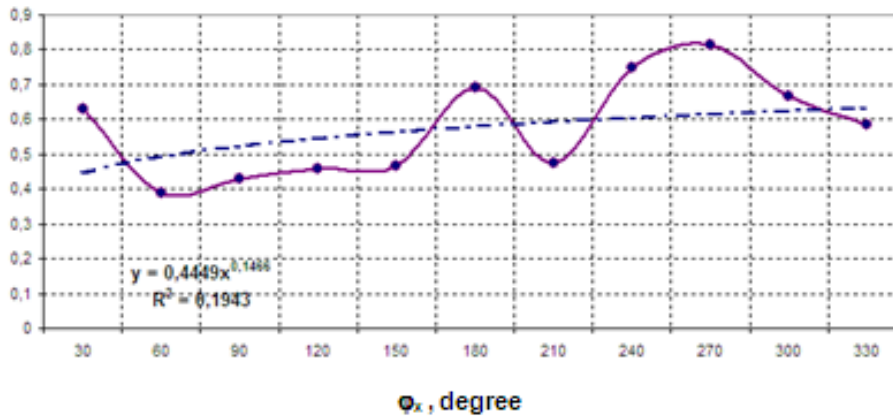


# Phase Shift Measurement Absolute Error at 100 Hz and 1 kHz

$\Delta\phi_x$ , degree



$\Delta\phi_x$ , degree



# Maximum Absolute Errors

Waveform	Frequency, Hz	Max. Absolute Error, °
<b>Sine</b>	100	$\pm 0.17$
	1 000	$\pm 0.8$
<b>Rectangular</b>	10	$\pm 0.008$
	100	$\pm 0.06$
	1 000	$\pm 0.7$
	4 000	$\pm 2.3$

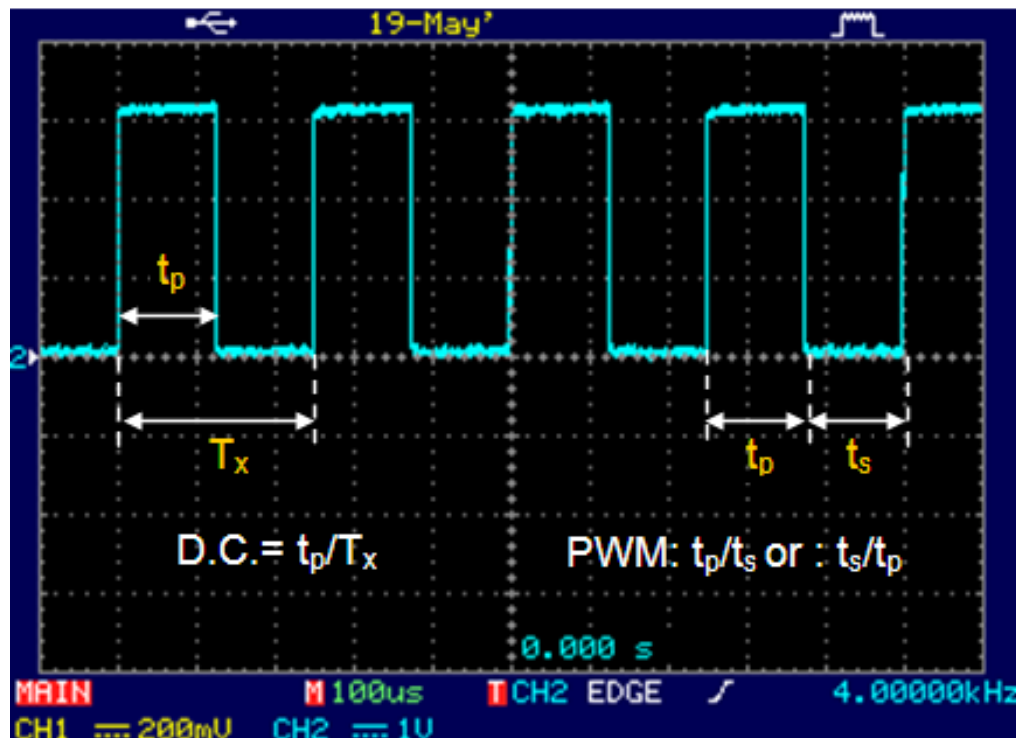
# Commands for RS232, I2C and SPI Interfaces

**M02** ; Select phase shift measurement mode  
**S** ; Start measurement  
**C** ; Check result status: 'r' if ready or 'b' if busy  
**R** ; Get result in BCD ASCII format

**<06><02>** ; Select phase shift measurement mode  
**<09>** ; Start measurement  
**<03>** ; Check result status: '0' if ready or not '0' if busy  
**<07>** ; Get measurement result in BCD format

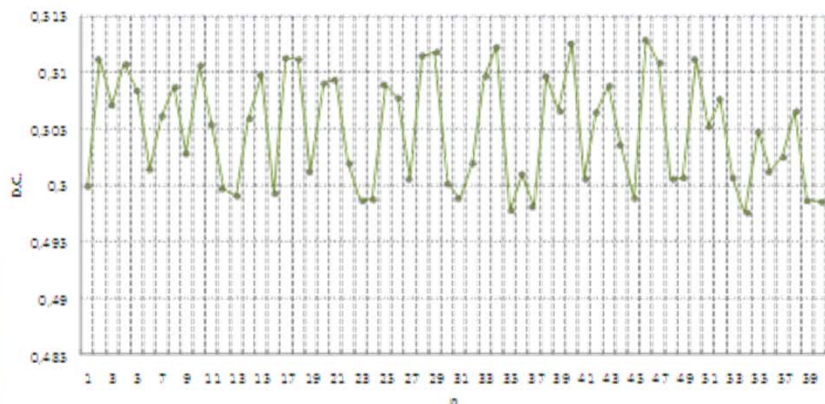
**<06><02>** ; Select phase shift measurement mode  
**<09>** ; Start measurement  
**<03><FF>** ; Check result status: '0' if ready or not '0' if busy  
**<07><FF>** ; Get measurement result in BCD format

# Duty-Cycle and PWM Signal





# Duty-Cycle Measurement at 100 kHz and 500 Hz

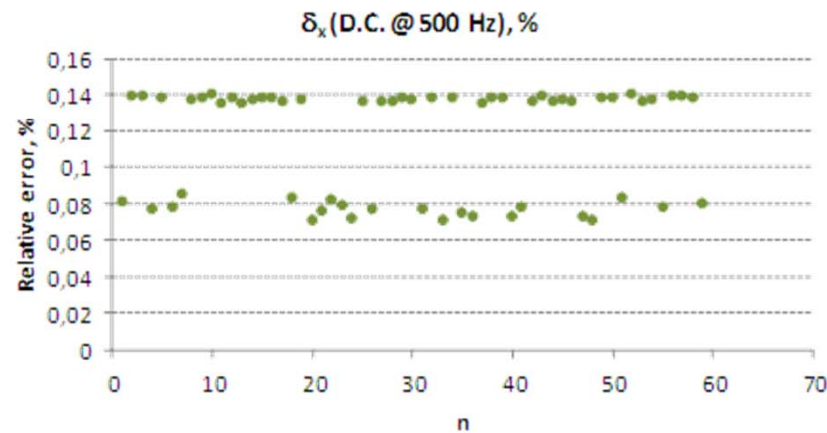
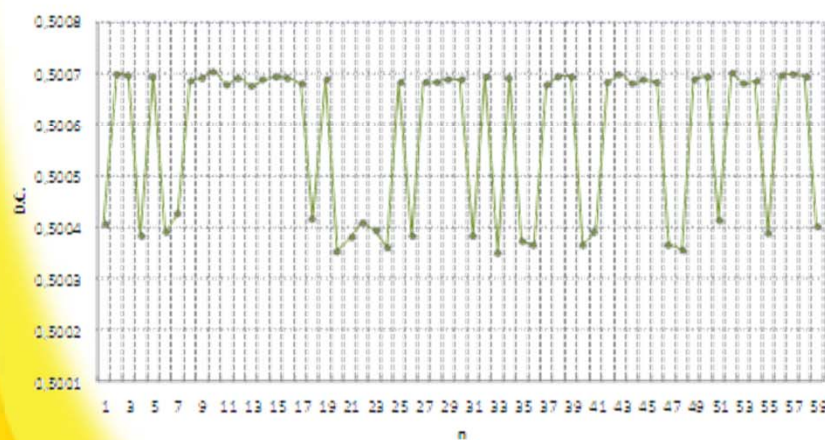


$\Pi$  50%  
 AC 1M $\Omega$  5V BW NR

**CH 1 Pos Duty Cycle** Gate  
**50.00 Pct**

Mean: 50.00 Pct	Max: 50.00 Pct
StdDev: 0.00 Pct	Min: 50.00 Pct
Count: 7 472	Pk to Pk: 0.00 Pct

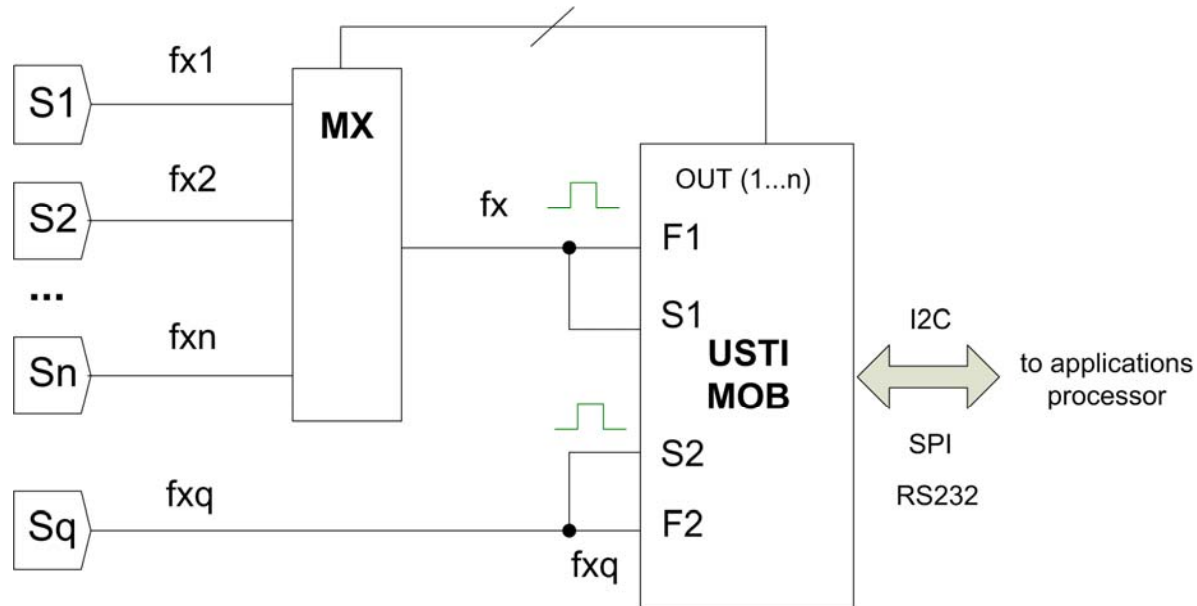
**Math** Math On  
 Statistics Off  On Reset Stats



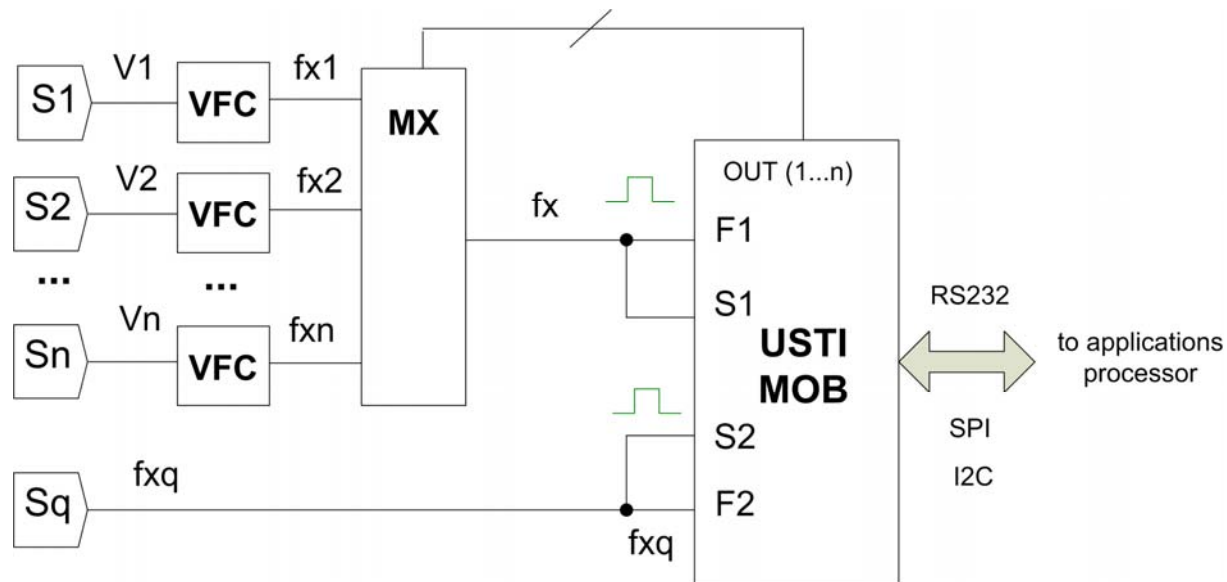
# Duty-cycle Values vs. Frequencies

Frequency, kHz	Duty-cycle, %
< 0.5	1 ... 99.3
1	1.5 ... 98
10	15 ... 80
20	30 ... 71
30	46 ... 60
> 40	50

# Multisensor System for Smartphones and Tablets



# Analog Sensors Interfacing



# Measurement Time Calculation

$$T_{meas} = t_{conv} + t_{comm} + t_{calc}$$

$$\begin{cases} t_{conv} = \frac{1}{f_x} & \text{if } \frac{N_\delta}{f_0} < T_x \\ t_{conv} = \frac{N_\delta}{f_0} + (0 \div T_x) & \text{if } \frac{N_\delta}{f_0} \geq T_x \end{cases}$$

where  $N_\delta = 1/\delta$  is the number proportional to the required programmable relative error  $\delta$

The calculation time depends on operands and is as usually  
 $t_{calc} \leq 20$  ms

# Communication Time

- **For RS232 interface:**  $t_{comm} = 10 \cdot n \cdot t_{bit}$

where  $t_{bit} = 1/300, 1/600, 1/1200, 1/2400, 1/4800, 1/9600, 1/14400, 1/19200, 1/28800, 1/38400$  or  $1/76800$  is the time for one bit transmitting;  $n$  is the number of bytes ( $n = 13 \div 24$  for ASCII format).

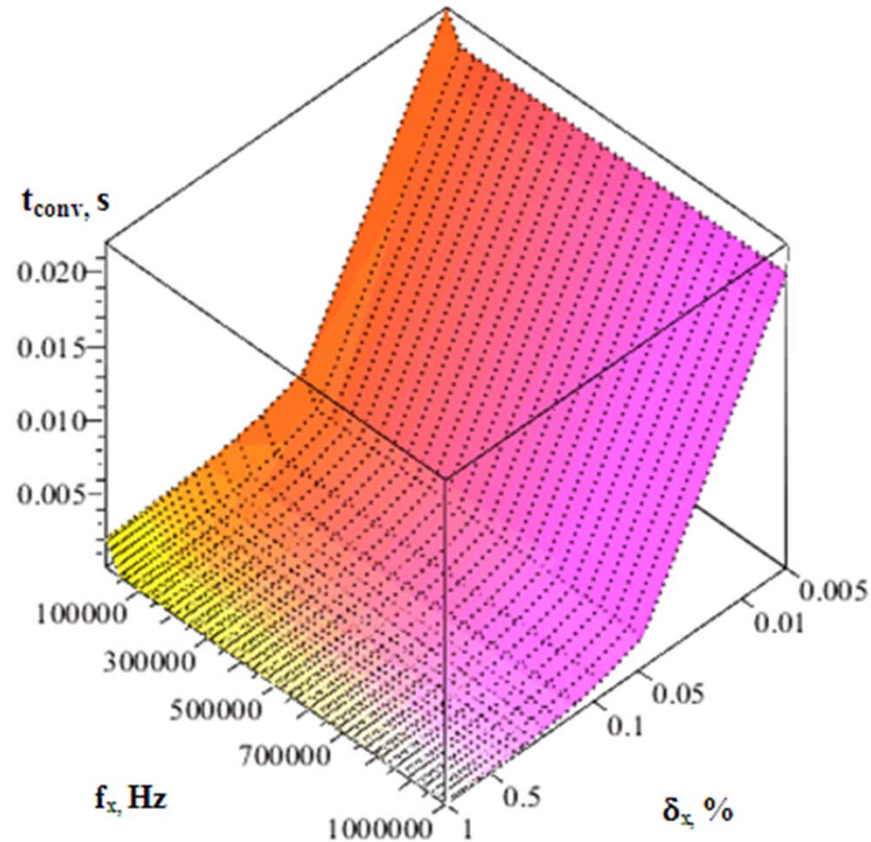
- **For SPI interface:**  $t_{comm} = 8 \cdot n \cdot \frac{1}{f_{SCLK}}$

where  $f_{SCLK} = 28$  kHz is the serial clock frequency;  $n=12 \div 13$  is the number of bytes: for BCD ( $n=13$ ) or binary ( $n=12$ ) formats

- **For I<sup>2</sup>C interface:**  $t_{comm} = 8 \cdot n \cdot \frac{1}{f_{SCL}}$

where  $f_{SCL} = 20$  kHz is the serial clock frequency  $n=12 \div 13$  is the number of bytes for measurement result: BCD ( $n = 13$ ) or binary ( $n = 12$ ).

# Dependence of $t_{conv}$ ( $\delta_x, f_x$ ) in the frequency range from 0.5 to 1 MHz

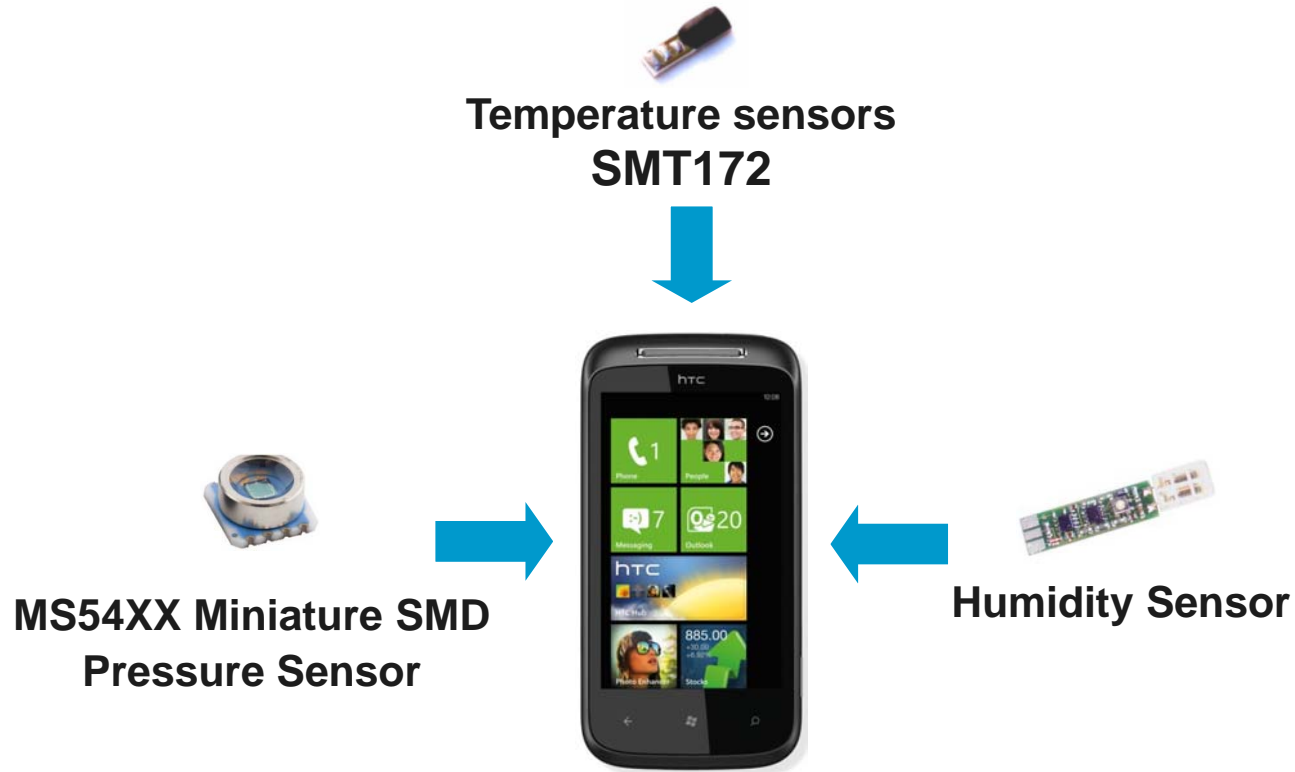


# Sensors Systems Examples

- ① Introduction: Markets and Definitions
- ② Modern Challenges
- ③ Sensor Systems Design: Introduction
- ④ Advanced Sensor Systems Design
- ⑤ Sensors Systems Examples**
- ⑥ The Future and Summary



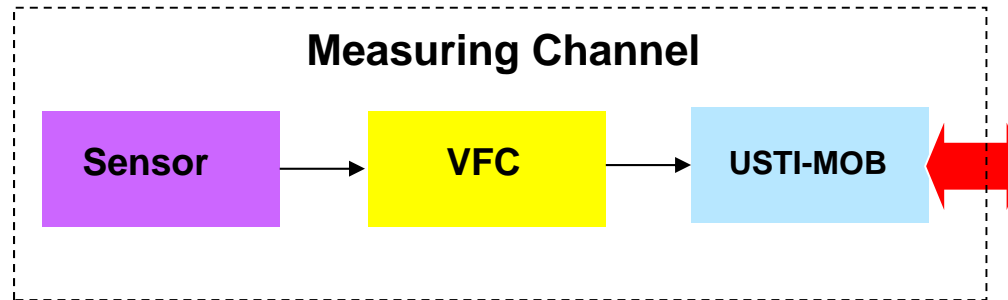
# Smartphone based Weather Station



# Commands for USTI-MOB (I2C Interface)

<06><00>	; Frequency measurement in the 1 <sup>st</sup> channel (humidity)
<02><02>	; Set up the conversion error 0.25 %
<09>	; Start a measurement
<03>	; Check result status: '0' if ready or not '0' if busy
<07>	; Get result in BCD format
<06><14>	; Duty-cycle measurement in the 2nd channel (temperature)
<09>	; Start a measurement
<03>	; Check result status: '0' if ready or not '0' if busy
<07>	; Get result in BCD format
<06><12>	; Resistance-bridge $B_x$ measurement mode (pressure)
<10><13>	; Set the charging time 20 ms
<09>	; Start measurement
<03>	; Check result status: '0' if ready or not '0' if busy
<07>	; Read conversion result

# Measuring Channel



## Relative Error's Components:

$\pm\delta_s, \%$

$\pm\delta_{VFC}, \%$

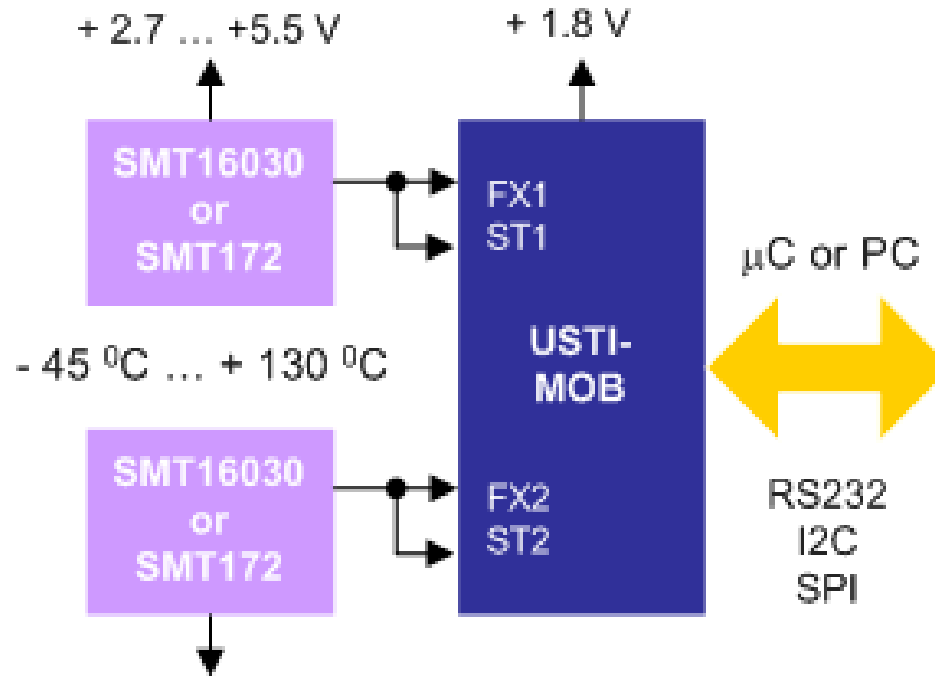
$\pm\delta_q, \%$  - quantization error

$\pm\delta_o, \%$  - reference error

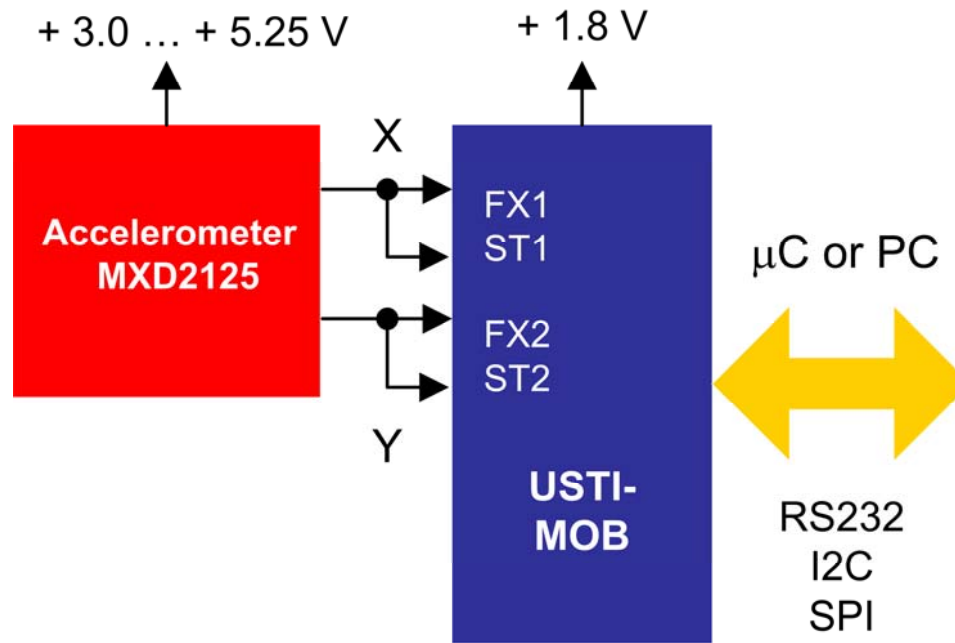
## Main considerations:

- USTI-MOB's relative error ( $\delta_q$ ) must be in one order less (or at the least in 5 times less than the sensor's error)
- The reference error for calibrated USTI-MOB is  $\delta_o = \pm 0.00001 \%$

# Low Power Consumption Temperature Sensor Systems



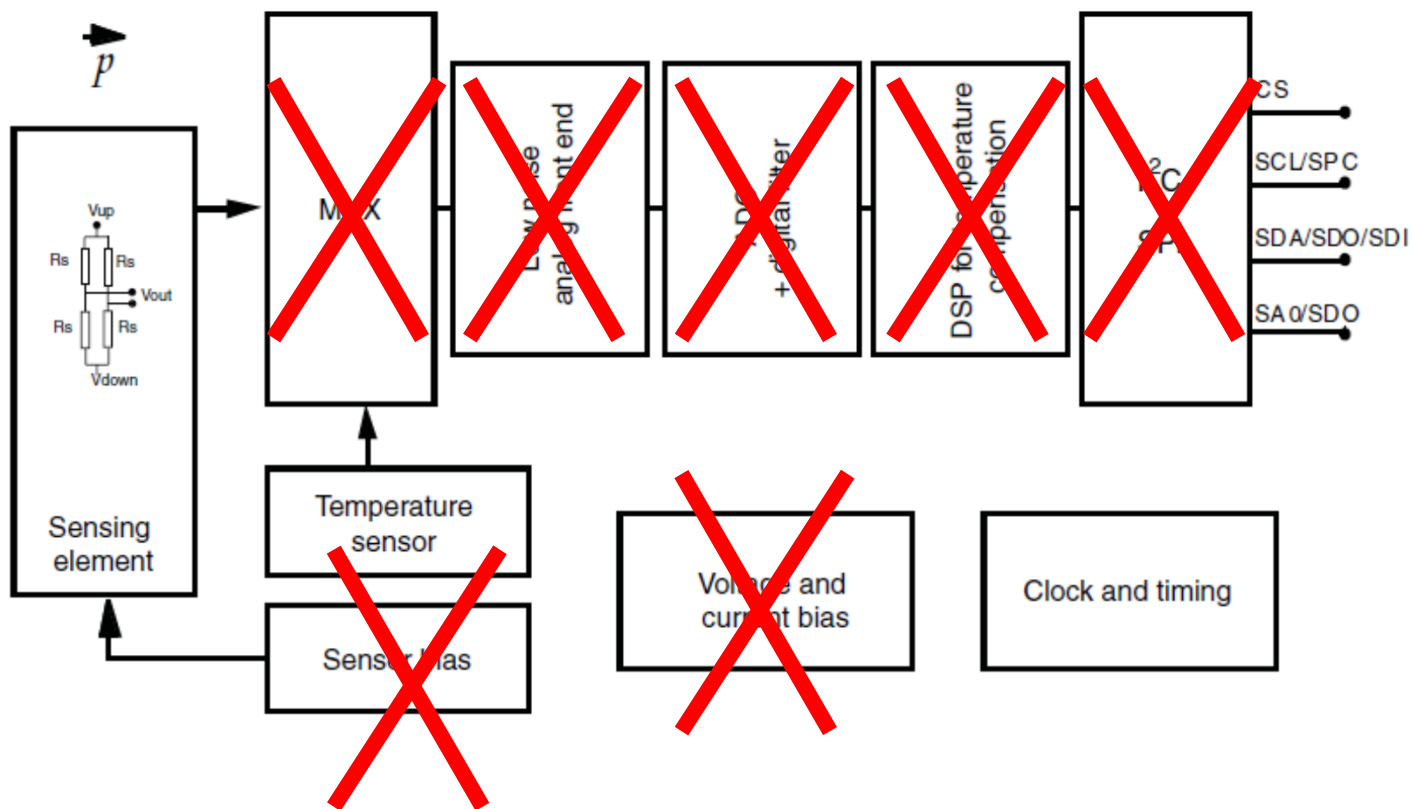
# Accelerometer Sensor Systems



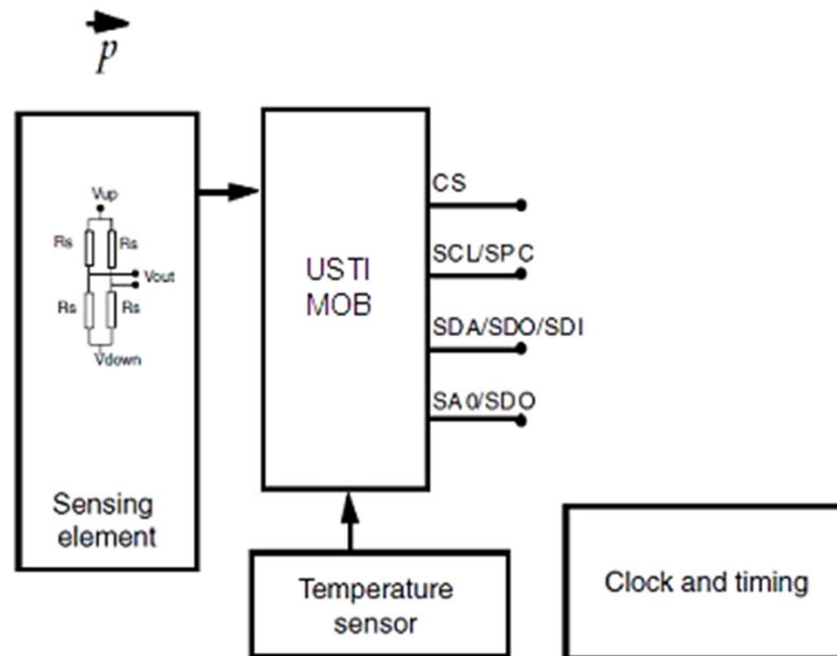
# Commands for RS232 Interface

- M04** ; Select duty-cycle measurement mode
- S** ; Start measurement
- C** ; Check result status: 'r' if ready or 'b' if busy
- R** ; Get result in BCD ASCII format

# Barometric Pressure Sensor (I)



# Barometric Pressure Sensor (II)



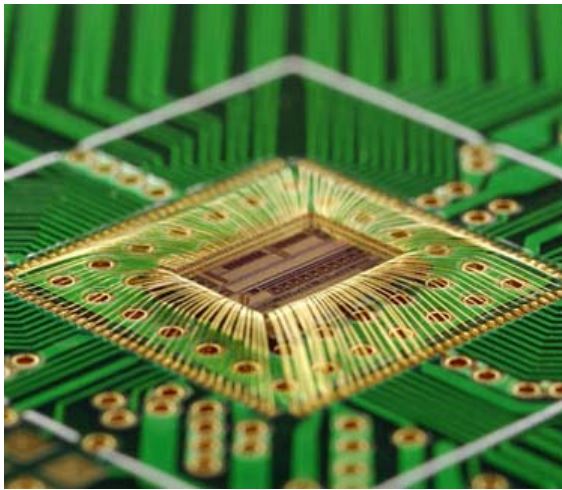


# USTI-MOB Custom Design



- Extended functionality
- New measuring modes
- Customized units of measurements
- Improved metrological performance and communication interfaces

# The Future



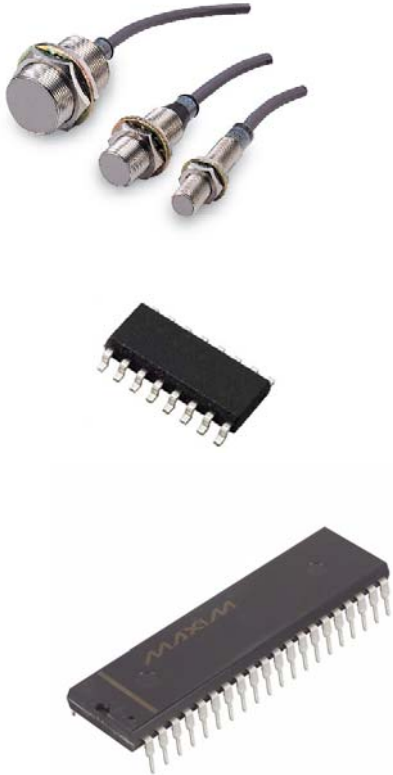
- USTI-WSN
- ASIC or IC
- SoC/SiP

# USTI-WSN



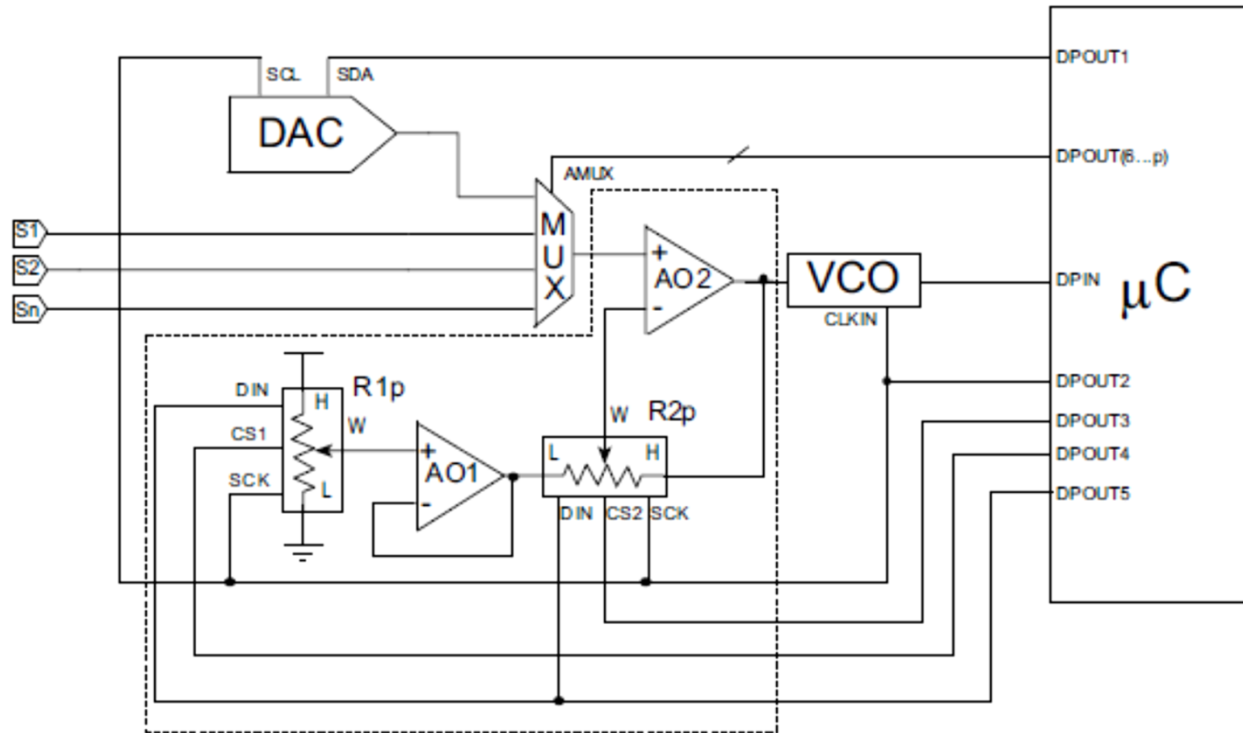
- The same metrological performance and functionality as USTI IC
- Includes RF-CMOS 2.4 GHz radio transceiver
- IEEE 802.15.4, ZigBee, IPv6/6LoWPAN, RF4CE, SP100, WirelessHART and ISM applications
- Supply voltage is 1.8 V
- Current consumption is less than 18.8 mA in active mode
- 64-pad QFN package

# Traditional Approach



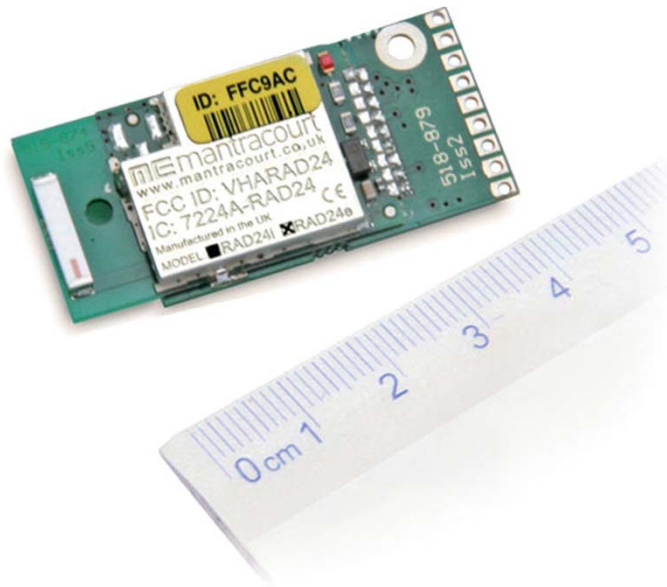
- Analog sensors with voltage or current outputs
- Analog multiplexer
- Multichannel ADC

# Sensor Node Interface



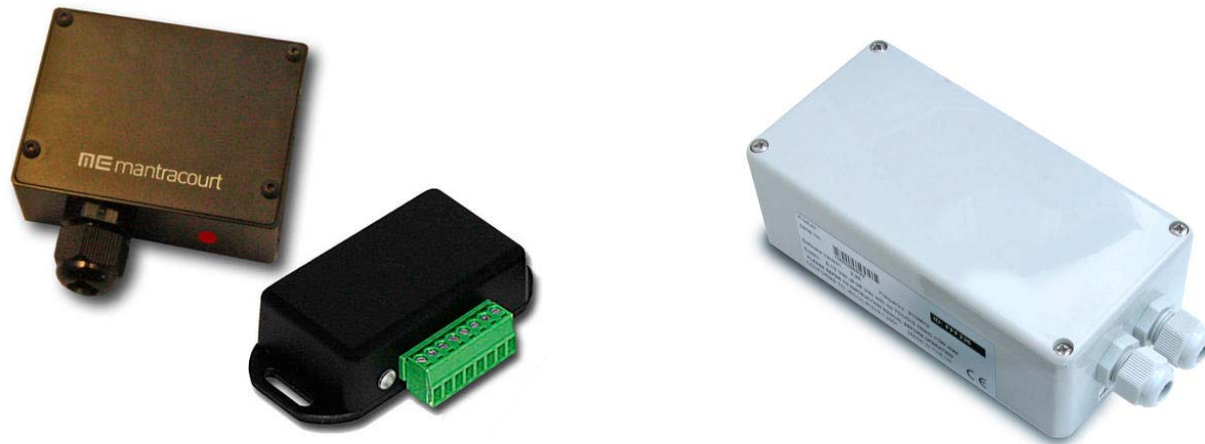
A. Bayo, N. Medrano, B. Calvo, S. Celma, A Programmable Sensor Conditioning Interface for Low-Power Applications, *Proc. of the Eurosensors XXIV*, 5-8 September, 2010, Linz, Austria, Procedia Engineering, Vol. 5, 2010, pp. 53–56.

# Wireless Telemetry Pulse Acquisition Module T24-PA



- Frequency range: 0.5 Hz ... 3 kHz
- Relative error: 0.15 % ... 0.25 %
- Frequency, time and RPM measuring modes

# Pulse-to-Wireless Converters



# Sensor Node Architecture

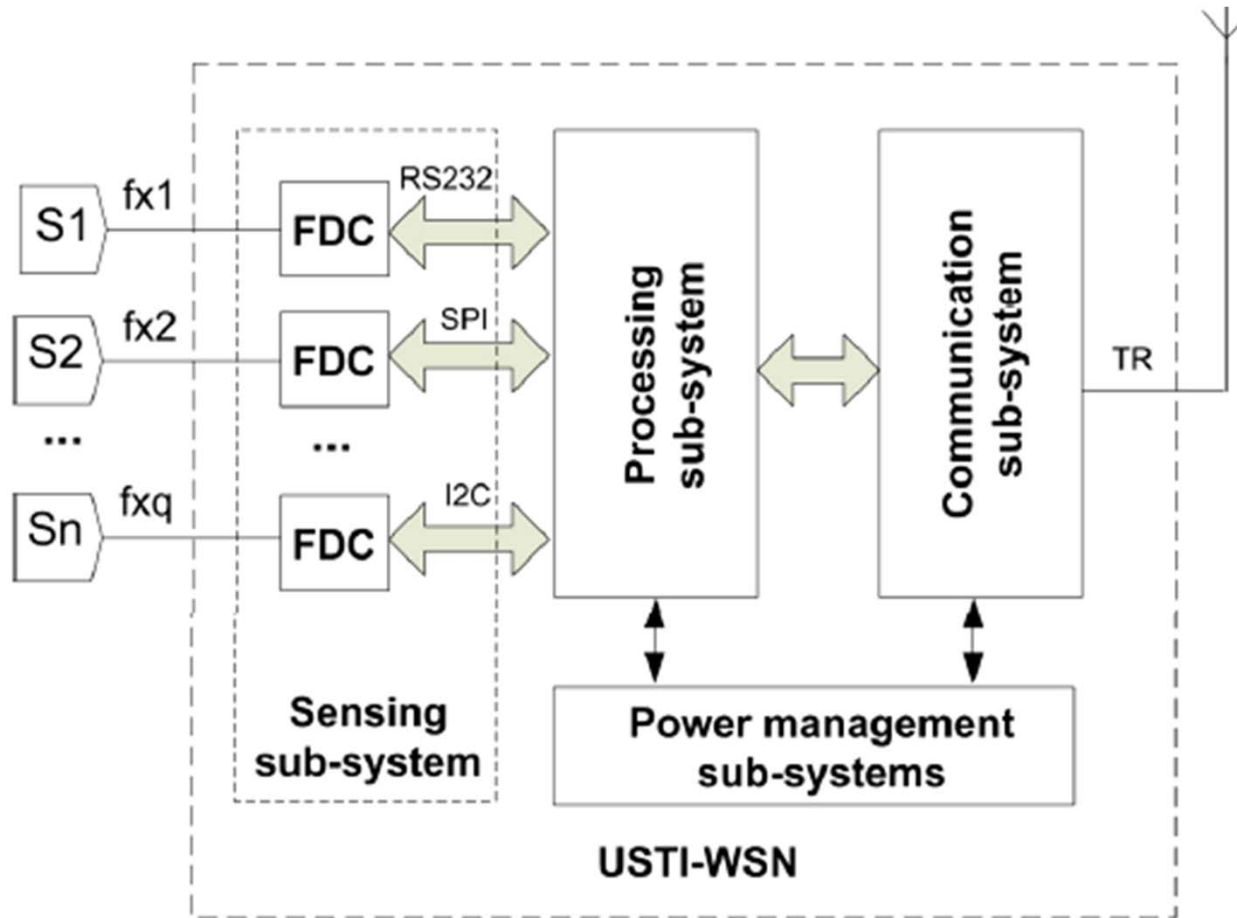
- Sensing Sub-system
- Processing Sub-system
- Communication Sub-system
- Power Management Sub-system



# Sensor Node Architecture

- Sensing Sub-system
- Processing Sub-system
- Communication Sub-system
- Power Management Sub-system

# Node on Chip



# Comparative Performances

Parameter		
	T24-PA	USTI-MOB IC
Relative error, %	0.15 ... 0.25	0.0009
Frequency Range, Hz	0.5 ... 3 000	0.25 ... 1 950 000
Min.Time interval, s	333E-06 ... 2	10E-06 ... 250
RPM range (presuming 1 pulse/rev), rpm	30 ... 180 000	3 ... unlimited
Active Supply Current, mA	35	0.85

# Price Comparison

ICs	Manufacturers	Price, \$ US (in quantities of 1, 000)
<b>ADS1278</b> , 24-bit, 8 channels, SPI	Texas Instruments	23.95
<b>USTI-MOB</b> , 3 channels, SPI, I2C, RS232 + any digital multiplexer (8 channels or more)	Excelera, S.L.	16.95
<b>Saving:</b>		23.95-16.95 = 7.00

# Series of UFDC and USTI ICs

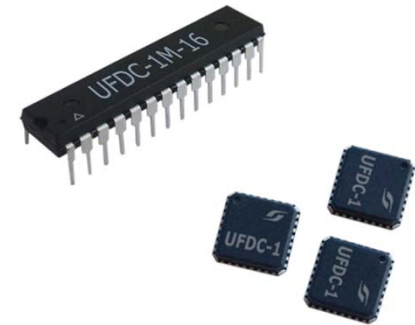
Universal Sensors and Transducer Interface (USTI)



USTI-EXT for Auto, Aerospace & Defense applications



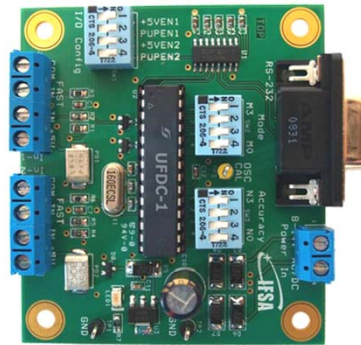
Universal Frequency-to-Digital Converter (UFDC-1 & 1M-16)



USTI MOB for ultra-low power applications



Evaluation boards



# Current Consumption Comparison

IC	Active Supply Current, mA
USTI-MOB	0.85
USTI	11
USTI-EXT	11
USTI-WSN *	~ 18.8
UFDC-1-16	20
UFDC-1	20

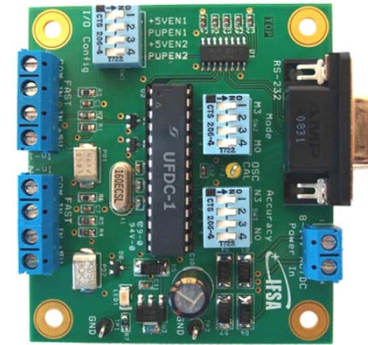
\* - coming soon

# Conclusions



- Quasi-digital sensors and digital sensors on its basis are more attractive for mobile devices and IoT because of they let to eliminate current technological limitations
- Proposed advanced design approach lets significantly increase a sensor system integration level and metrological performance
- A lot of different sensors can be integrated by the same way in any mobile devices and IoT without complex sensor fusion algorithms

# Reading and Practice



[http://www.sensorsportal.com/HTML/BOOKSTORE/Digital\\_Sensors.htm](http://www.sensorsportal.com/HTML/BOOKSTORE/Digital_Sensors.htm)



# Contact Information



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Web: <http://www.excelera.io>

# Questions & Answers

